

Deutsche Akkreditierungsstelle

Annex to the Partial Accreditation Certificate D-K-15118-01-01 according to DIN EN ISO/IEC 17025:2018

Valid from: 11.03.2025

Date of issue: 11.03.2025

This annex is a part of the accreditation certificate D-K-15118-01-00.

Holder of partial accreditation certificate:

Kessler QMP GmbH
Nisterberger Weg 16, 57520 Friedewald

with the location

Kessler QMP GmbH
Nisterberger Weg 16, 57520 Friedewald

The calibration laboratory meets the requirements of DIN EN ISO/IEC 17025:2018 to carry out the conformity assessment activities listed in this annex. The calibration laboratory meets additional legal and normative requirements, if applicable, including those in relevant sectoral schemes, provided that these are explicitly confirmed below.

The management system requirements of DIN EN ISO/IEC 17025 are written in the language relevant to the operations of calibration laboratories and they conform to the principles of DIN EN ISO 9001.

This certificate annex is only valid together with the written accreditation certificate and reflects the status as indicated by the date of issue. The current status of any given scope of accreditation can be found in the directory of accredited bodies maintained by Deutsche Akkreditierungsstelle GmbH at <https://www.dakks.de>.

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Calibrations in the fields:

Dimensional quantities

Length

- Length gauges
- Diameter ^{b)}
- Form error
- Length measuring instruments ^{b)}
- Length measuring devices ^{a)}
- Flatness ^{a)}
- Straightness
- Line scales, distances
- Thread ^{b)}
- Gear quantities

Coordinate measuring technology

- Application coordinate measuring machines
- Coordinate measuring machines ^{c)}

Angle

- Angle gauges
- Inclination measuring instruments

Electrical quantities

DC and low frequency quantities

- DC voltage ^{b)}
- AC voltage ^{b)}
- DC current ^{b)}
- AC current ^{b)}
- DC resistance ^{b)}
- Electric power ^{b)}

Time and frequency

- Frequency
- Time interval

High frequency and radiation quantities

High frequency quantities

- Oscilloscope quantities ^{b)}
- Rise time ^{b)}
- Band width ^{b)}

^{a)} also on-site-calibration

^{b)} also calibration in the mobile laboratory

^{c)} only on-site-calibration

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Within the measurands/calibration items marked with *, the calibration laboratory is permitted, without being required to inform and obtain prior approval from DAkkS, to use calibration standards or equivalent calibration procedures listed here with different issue dates.

The calibration laboratory maintains a current list of all calibration standards / equivalent calibration procedures within the flexible scope of accreditation.

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Length Gauge blocks * made of steel according to DIN EN ISO 3650:1999	0.5 mm to 100 mm featuring the nominal values of the steel standards	VDI/VDE/DGQ 2618 part 3.1:2004 Measurement of the deviation of the central length l_c from the nominal value l_n by comparison measurement Measurement of the deviations f_o and f_u from the central length by 5 points comparison measurement For the smallest measurement uncertainties, the wringability and the wringing characteristics of both measuring surfaces must be checked using an appropriate optical flat	For the central length: $0.08 \mu\text{m} + 0.8 \cdot 10^{-6} \cdot l$	l = gauge block length
			For the deviations f_o and f_u from the central length: 0.05 μm	
			For the central length: $0.1 \mu\text{m} + 1.1 \cdot 10^{-6} \cdot l$	
Gauge blocks * made of ceramics according to DIN EN ISO 3650:1999			For the deviations f_o and f_u from the central length: 0.07 μm	
Gauge blocks * made of tungsten carbide according to DIN EN ISO 3650:1999			For the central length: $0.1 \mu\text{m} + 3.3 \cdot 10^{-6} \cdot l$	
Setting plug gauges * Diameter	1 mm to 500 mm	VDI/VDE/DGQ 2618 part 4.1:2006, option 1, option 2 Option 3, option 4	$0.4 \mu\text{m} + 5 \cdot 10^{-6} \cdot d$	d = measured diameter
			$0.8 \mu\text{m} + 5 \cdot 10^{-6} \cdot d$	
Roundness deviation	to 40 μm	VDI/VDE/DGQ 2618 part 4.1:2006	$0.3 \mu\text{m} + 2.5 \cdot 10^{-2} \cdot RONt$	
Straightness deviation	to 40 μm		$0.4 \mu\text{m} + 2.5 \cdot 10^{-2} \cdot STRt$	
Parallelism deviation	to 40 μm		$0.7 \mu\text{m} + 2.5 \cdot 10^{-2} \cdot PART$	
Setting ring gauges * Diameter	2 mm to 200 mm	VDI/VDE/DGQ 2618 part 4.1:2006 option 1, option 2 Option 3, option 4	$0.6 \mu\text{m} + 3 \cdot 10^{-6} \cdot d$	d = measured diameter
			$0.8 \mu\text{m} + 3 \cdot 10^{-6} \cdot d$	
Roundness deviation	to 40 μm	VDI/VDE/DGQ 2618 part 4.1:2006	$0.3 \mu\text{m} + 2.5 \cdot 10^{-2} \cdot RONt$	
Straightness deviation	to 40 μm		$0.4 \mu\text{m} + 2.5 \cdot 10^{-2} \cdot STRt$	
Parallelism deviation	to 40 μm		$0.7 \mu\text{m} + 2.5 \cdot 10^{-2} \cdot PART$	
Roundness deviation	to 40 μm	TK 40:2020-01	$0.3 \mu\text{m} + 2.5 \cdot 10^{-2} \cdot RONt$	
Straightness deviation	to 40 μm		$0.4 \mu\text{m} + 2.5 \cdot 10^{-2} \cdot STRt$	
Parallelism deviation	to 40 μm		$0.7 \mu\text{m} + 2.5 \cdot 10^{-2} \cdot PART$	
Measuring pins / Pins for screw threads * Diameterr	1 mm to 50 mm	VDI/VDE/DGQ 2618 part 4.2:2007, option 1, option 2	0.6 μm	
	0.17 mm to 50 mm	Option 3	0.8 μm	
Roundness deviation	to 40 μm	VDI/VDE/DGQ 2618 part 4.1:2006	$0.3 \mu\text{m} + 2.5 \cdot 10^{-2} \cdot RONt$	
Straightness deviation	to 40 μm		$0.4 \mu\text{m} + 2.5 \cdot 10^{-2} \cdot STRt$	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Taper gauges * Taper plug gauges and Taper ring gauges Diameter	1 mm to 200 mm	VDI/VDE/DGQ 2618 part 4.12:2007, option 1 and 2	The uncertainty of measurement is determined with a uncertainty measurement balance sheet on the basic of the guideline VDI/VDE 2617 part 11:2011. The uncertainty of measurement is specified with a coverage probability of approximately 95 % (coverage factor $k = 2$) Exemplary of Uncertainty of measurement for a measuring problem: Taper plug gauge with a gap of 61 mm to the measuring high and a gap of 2 mm to the last measuring plane at the evaluation flat: $U = 0.42 \mu\text{m}$	
Penetration radius				
Angular deviation	to 5'		$(90 \text{ mm}/l)''$	Statement of l in mm
Roundness deviation	to 40 μm		0.5 μm	
Straightness deviation	to 40 μm		0.5 μm	
Gap gauges *	5 mm to 200 mm	VDI/VDE/DGQ 2618 part 4.7:2005	$3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	$l =$ measured length
Straight edges * Flatness deviation	to 1000 mm	VDI/VDE/DGQ 2618 part 5.1:2013	$1.1 \mu\text{m} + 1.6 \cdot 10^{-6} \cdot l$	
Parallelism deviation			$2.2 \mu\text{m} + 3.2 \cdot 10^{-6} \cdot l$	
Knife straight edges *	to 1000 mm	VDI/VDE/DGQ 2618 part 5.2:2013	$1.1 \mu\text{m} + 1.6 \cdot 10^{-6} \cdot l$	
Surface plates * Flatness deviation	to 50 μm	VDI/VDE/DGQ 2618 part 6.2:2014 to 8 m edge length	$1.1 \mu\text{m} + 2.7 \cdot 10^{-6} \cdot l$	$l =$ measured length with inclination measuring instruments
Steel squares * Flatness deviation	to 1000 mm	VDI/VDE/DGQ/DKD 2618 part 7.1:2019	$1.1 \mu\text{m} + 1.6 \cdot 10^{-6} \cdot l$	$l =$ measured length
Angular deviation			$3.1 \mu\text{m} + 5 \cdot 10^{-6} \cdot l$	
Centring angles Flatness deviation	to 1000 mm	TK 90:2021-09	$1.1 \mu\text{m} + 1.6 \cdot 10^{-6} \cdot l$	
Angular deviation			$3.1 \mu\text{m} + 5 \cdot 10^{-6} \cdot l$	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 5 of 29

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Protractors *	0° to 360°	VDI/VDE/DGQ 2618 part 7.2:2008	5 μm	
Flatness deviation			5 μm	
Parallellism deviation				
Angle *				
Scale interval 5'	0° to 360°		4'	
Scale interval 1°	0° to 180°		24'	
Calipers for external, internal and depth dimensions *	0 mm to 300 mm	VDI/VDE/DGQ 2618 part 9.1:2006	$30 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	l = final value of the measuring range
	> 300 mm to 1500 mm		$50 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	
	> 1500 mm to 3000 mm		$70 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	
Depth calipers *	0 mm to 300 mm	VDI/VDE/DGQ 2618 part 9.2:2006	$30 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	
	> 300 mm to 1500 mm		$50 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	
Height calipers * with analogue display	0 mm to 600 mm	VDI/VDE/DGQ 2618 part 9.3:2006	$30 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	
			with digital display	
Micrometers *	0 mm to 100 mm	VDI/VDE/DGQ 2618 part 10.1:2001	$3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
	> 100 mm to 500 mm		$4 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
Micrometers	> 500 mm to 1000 mm	TK 2:2020-02	$5 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
	> 1000 mm to 1500 mm		$6 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
Reference gauges for micrometers *	25 mm to 500 mm	VDI/VDE/DGQ 2618 part 4.4:2009	$2 \mu\text{m} + 5 \cdot 10^{-6} \cdot l$	
	> 500 mm to 1500 mm		$3 \mu\text{m} + 5 \cdot 10^{-6} \cdot l$	
Micrometers with interchangeable inserts *	0 mm to 100 mm	VDI/VDE/DGQ 2618 part 10.2:2010	$3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
	> 100 mm to 300 mm		$5 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
Micrometers with dial indicator *	0 mm to 100 mm	VDI/VDE/DGQ 2618 part 10.3:2002	$3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
Micrometers heads *	0 mm to 50 mm	VDI/VDE/DGQ 2618 part 10.4:2008	$3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	l = measured length
Depth micrometers *	0 mm to 100 mm	VDI/VDE/DGQ 2618 part 10.5:2010	$3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
	> 100 mm to 500 mm		$4 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
Internal micrometers with two-point contact *	25 mm to 100 mm	VDI/VDE/DGQ 2618 part 10.7:2010	$3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
	> 100 mm to 500 mm		$4 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
	> 500 mm to 1000 mm		$5 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
	> 1000 mm to 1500 mm		$6 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
Extensions for internal micrometers with two-point contact *	25 mm to 500 mm	VDI/VDE/DGQ 2618 part 10.7:2010	$2 \mu\text{m} + 5 \cdot 10^{-6} \cdot l$	
	> 500 mm to 1500 mm		$3.5 \mu\text{m} + 5 \cdot 10^{-6} \cdot l$	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 6 of 29

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Internal micrometers with three-point contact *	3 mm to 200 mm	VDI/VDE/DGQ 2618 part 10.8:2002	$4 \mu\text{m} + 10 \cdot 10^{-6} \cdot d$	d = measured diameter
Internal measuring instruments	3 mm to 200 mm	TK 57:2021-02	$2 \mu\text{m} + 10 \cdot 10^{-6} \cdot d$	d = measured diameter
Dial gauges * Scale interval > 1 μm	to 100 mm	VDI/VDE/DGQ/DKD 2618 part 11.1:2021	$3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	l = measured length
Scale interval $\leq 1 \mu\text{m}$			$2 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
Dial indicators *	to 3 mm	VDI/VDE/DGQ 2618 part 11.2:2002	1.1 μm	
Lever gauges *	to 1.6 mm	VDI/VDE/DGQ 2618 part 11.3:2002	1.2 μm	
Dial gauges * with digital display	to 100 mm	VDI/VDE/DGQ/DKD 2618 part 11.4:2020	$3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
Lever gauges (quicktests) for external measurements *	0 mm to 100 mm	VDI/VDE/DGQ 2618 part 12.1:2005	6 μm	
Thickness gauges * Scale interval 1 μm	0 mm to 30 mm	VDI/VDE/DGQ 2618 part 12.1:2005	$1.3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	l = measured length
Scale interval 10 μm			$6 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
Lever gauges (quicktests) for internal measurements *	2.5 mm to 500 mm	VDI/VDE/DGQ 2618 part 13.1:2005	6 μm	
Bore gauges with two-point contact * Form I – III	1 mm to 800 mm	VDI/VDE/DGQ 2618 part 13.2:2005	1.8 μm	Measuring length up to 3 mm
Electical probe and measuring device *	0 mm to 10 mm	VDI/VDE/DGQ 2618 part 14.1:2010	1.4 μm	
Feeler gauges	10 μm to 2 mm	TK 19:2021-02	1 μm	
Measuring tape, Circumference tape measure	0 m to 100 m	TK 85:2020-01	$56 \mu\text{m} + 46 \cdot 10^{-6} \cdot l$	l = measured length
Rules	0 m to 5 m	TK 85:2020-01	$56 \mu\text{m} + 46 \cdot 10^{-6} \cdot l$	Graduated metal rules, reference- and plotting scale, rules, folding rules
Diameter tape measure	0 m to 10 m	TK 85:2020-01	$56 \mu\text{m} + 46 \cdot 10^{-6} \cdot l$	
Setting dimension for height gauges	to 20 mm	TK 89:2020-01	0.5 μm	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Height gauges *	0 mm to 1000 mm	VDI/VDE/DGQ 2618 part 16.1:2009	$1.0 \mu\text{m} + 1.4 \cdot 10^{-6} \cdot l$	till 1000 mm lead length
Deviation from straightness and perpendicularity	to 40 μm		$3 \mu\text{m}$	$l = \text{measured length}$
Horizontal length measuring device *	0 mm to 200 mm	VDI/VDE/DGQ 2618 part 17.1:2015	$0.12 \mu\text{m} + 0.6 \cdot 10^{-6} \cdot l$	with gauge blocks
Thread gauges * single-start cylindrical external and internal threads with straight flanks, symmetrical profile and nominal thread angle 55° to 60°				
External thread with nominal lead 0.25 mm to 5.5 mm Simple pitch diameter	Nominal diameter: 2 mm to 200 mm	VDI/VDE/DGQ 2618 part 4.8:2006 (option 1) Three wire procedure (vertical to thread axis)	$2.8 \mu\text{m} + 10 \cdot 10^{-6} \cdot d$	$d = \text{pitch diameter}$
Internal thread with nominal lead 0.7 mm to 6.0 mm Simple pitch diameter	Nominal diameter: 4 mm to 200 mm	VDI/VDE/DGQ 2618 part 4.9:2006 (option 1) Two ball procedure (vertical to thread axis)	$2.8 \mu\text{m} + 10 \cdot 10^{-6} \cdot d$	$d = \text{Pitch diameter}$
Angle gauges 90°	Leg length 40 mm to 1000 mm	TK 16:2021-05 pointwise measurement	2.4 μm	Angle auges of hard stone according to DIN 875-2:2008
Inclination measuring instruments elektronic and mechanical	$\pm 20 \text{ mm/m}$	TK 56:2021-05	$2.4 \mu\text{m} + 10 \cdot 10^{-6} \cdot \alpha$	$\alpha = \text{Nominal angle}$
	$\pm 50 \text{ mm/m}$		21 $\mu\text{m/m}$	
	2.866° to 45°		0.01°	
	$\pm 90^\circ$		2.3 $\mu\text{m/m}$	
	Zero point deviation		1.5 $\mu\text{m/m}$	
Caliper for trailer artifice	to 60 mm	TK 84:2021-08	2 μm	
Caliper for trailer artifice	to 120 mm	TK 83:2021-08	8 μm	
Layer thickness gauges	20 mm	TK 91:2021-07	$0.7 \mu\text{m} + 180 \cdot 10^{-6} \cdot l$	$l = \text{measured length}$
Calibration foil	20 mm	TK 70:2021-07	$0.8 \mu\text{m} + 130 \cdot 10^{-6} \cdot l$	
Micrometers according to DIN 863-3 form D10	0 mm to 100 mm	TK 2:2021-02	$5 \mu\text{m} + 10 \cdot 10^{-6} \cdot d$	$d = \text{measured diameter}$

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Gear quantities Profile deviation * F_α $f_{i\alpha}$ $f_{H\alpha}$	10 mm $\leq d_b \leq$ 55 mm $L_\alpha \leq$ 4 mm	VDI/VDE 2612-1:2018 Substitution measuring with 3D coordinate measuring machines Correction of F_α and $f_{H\alpha}$ by comparison against gear measurement standard with $d_b = 29.88$ mm $L_\alpha = 4$ mm	1.6 μ m 0.6 μ m 1.4 μ m	Internal and external gears Symbols according to: ISO 1328-1:2013
F_α $f_{i\alpha}$ $f_{H\alpha}$	100 mm $\leq d_b \leq$ 150 mm $L_\alpha \leq$ 24 mm	or rather with $d_b = 122.192$ mm $L_\alpha = 24$ mm	1.6 μ m 0.6 μ m 1.4 μ m	
F_α $f_{i\alpha}$ $f_{H\alpha}$	10 mm $\leq d_b \leq$ 150 mm $L_\alpha \leq$ 24 mm	VDI/VDE 2612-1:2018 Measurement with 3D coordinate measuring machines without correction; traceability proved by involute measurement standard with $d_b = 29.88$ mm $L_\alpha = 4$ mm	2.7 μ m 1.0 μ m 1.7 μ m	
F_α $f_{i\alpha}$ $f_{H\alpha}$	10 mm $\leq d_b \leq$ 500 mm $L_\alpha \leq$ 50 mm	or rather with $d_b = 122.192$ mm $L_\alpha = 24$ mm	3.4 μ m 1.0 μ m 3.3 μ m	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 9 of 29

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Helix deviation *		VDI/VDE 2612-1:2018		Internal and external gears Symbols according to: ISO 1328-1:2013
F_{β} $f_{f\beta}$ $f_{H\beta}$	10 mm $\leq d \leq$ 55 mm $L_{\beta} \leq$ 40 mm $0^{\circ} < \beta \leq$ 5°	Substitution measuring with 3D coordinate measuring machines	1.5 μ m 0.7 μ m 1.3 μ m	
F_{β} $f_{f\beta}$ $f_{H\beta}$	100 mm $\leq d \leq$ 150 mm $L_{\beta} \leq$ 64 mm $0^{\circ} < \beta \leq$ 5°	Correction of F_{β} and $f_{H\beta}$ by comparison against gear measurement standard with $d = 34.5$ mm	1.5 μ m 0.7 μ m 1.3 μ m	
F_{β} $f_{f\beta}$ $f_{H\beta}$	100 mm $\leq d \leq$ 150 mm $L_{\beta} \leq$ 64 mm $10^{\circ} < \beta \leq$ 20°	$L_{\beta} = 30$ mm $\beta = 0^{\circ}$ or rather with	1.6 mm 0.7 mm 1.4 mm	
F_{β} $f_{f\beta}$ $f_{H\beta}$	100 mm $\leq d \leq$ 150 mm $L_{\beta} \leq$ 40 mm $25^{\circ} < \beta \leq$ 35°	$d = 104$ mm $L_{\beta} = 64$ mm $\beta = 0^{\circ}$ $\beta = 15^{\circ}$ r+l $\beta = 30^{\circ}$ r+l	1.9 μ m 0.7 μ m 1.7 μ m	
F_{β} $f_{f\beta}$ $f_{H\beta}$	10 mm $\leq d \leq$ 150 mm $L_{\beta} \leq$ 40 mm $0^{\circ} < \beta \leq$ 10°	VDI/VDE 2612-1:2018 Measurement with 3D coordinate measuring machines	2.8 μ m 1.0 μ m 2.6 μ m	
F_{β} $f_{f\beta}$ $f_{H\beta}$	100 mm $\leq d \leq$ 150 mm $L_{\beta} \leq$ 64 mm $5^{\circ} < \beta \leq$ 10°	without correction; traceability proved by helix measurement standard with	2.8 μ m 1.0 μ m 2.6 μ m	
F_{β} $f_{f\beta}$ $f_{H\beta}$	100 mm $\leq d \leq$ 150 mm $L_{\beta} \leq$ 64 mm $20^{\circ} < \beta \leq$ 25°	$d = 34.5$ mm $L_{\beta} = 30$ mm $\beta = 0^{\circ}$ or rather with	2.8 μ m 1.0 μ m 2.6 μ m	
F_{β} $f_{f\beta}$ $f_{H\beta}$	100 mm $\leq d \leq$ 150 mm $L_{\beta} \leq$ 64 mm $35^{\circ} < \beta \leq$ 45°	$d = 104$ mm $L_{\beta} = 64$ mm $\beta = 0^{\circ}$ $\beta = 15^{\circ}$ r+l $\beta = 30^{\circ}$ r+l	3.6 μ m 1.0 μ m 3.4 μ m	
F_{β} $f_{f\beta}$ $f_{H\beta}$	10 mm $\leq d \leq$ 500 mm $L_{\beta} \leq$ 200 mm $\beta = 0^{\circ}$	VDI/VDE 2612-1:2018 Measurement with 3D coordinate measuring machines	3.4 μ m 1.0 μ m 3.2 μ m	
F_{β} $f_{f\beta}$ $f_{H\beta}$	10 mm $\leq d \leq$ 500 mm $L_{\beta} \leq$ 200 mm $0^{\circ} < \beta \leq$ 35°	without correction; traceability proved by helix measurement standard with	3.9 μ m 1.0 μ m 3.7 μ m	
F_{β} $f_{f\beta}$ $f_{H\beta}$	10 mm $\leq d \leq$ 500 mm $L_{\beta} \leq$ 200 mm $35^{\circ} < \beta \leq$ 45°	$d = 34.5$ mm $L_{\beta} = 30$ mm $\beta = 0^{\circ}$ or rather with $d = 104$ mm $L_{\beta} = 64$ mm $\beta = 0^{\circ}$ $\beta = 15^{\circ}$ r+l $\beta = 30^{\circ}$ r+l	4.3 μ m 1.0 μ m 4.2 μ m	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 10 of 29

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Pitch deviation * F_p f_p F_x	10 mm $\leq d \leq$ 500 mm $\beta = 0^\circ$ $m_n > 0.5$ mm	VDI/VDE 2613:2003 Measurement according to „Rosette method“ with 3D coordinate measuring machines	1.0 μ m 0.9 μ m 1.1 μ m	Internal and external gears Symbols according to: ISO 1328-1:2013
F_p f_p F_x	10 mm $\leq d \leq$ 500 mm $\beta = 0^\circ$ $m_n > 0.5$ mm	VDI/VDE 2613:2003 Measurement with 3D coordinate measuring machines without correction; traceability proved by pitch measurement standard with $d = 67$ mm $m_n = 1$ mm	5.1 μ m 2.2 μ m 5.2 μ m	
Dimension over balls * M_{dK}	10 mm $\leq M_{dK} \leq$ 150 mm $\beta = 0^\circ$ $m_n > 0.5$ mm	DIN 21773:2014 Measurement of M_{dK} on length comparator compared to traceable setting standard i	1.4 μ m + 11 · 10 ⁻⁶ · l	Internal and external gears Symbols according to: ISO 1328-1:2013

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Coordinate measuring technology Prismatic, tapered and ball-shaped workpieces	Coordinate measuring machine with calibrated measuring volume of: X = 1200 mm Y = 1000 mm Z = 700 mm	TK 55:2020-02 Tactile measurements with single point probing with a coordinate measuring machine and determination of regular geometries through geometrical parameters (single-points, straight lines, planes, circles, balls, cylinders, tapers, toroid's) using the evaluation software of the coordinate measuring machine. Single-point measuring is carried out with fixed, predefined measuring force. Single point measurements in the form of „Self-centering measurements“ are not used within the accreditation. For ensuring metrological traceability calibration of a similar standard will be realized. Beyond that following limitations should be considered: <ul style="list-style-type: none"> - Measuring points have to be evenly distributed over the form element; - The calibration values can be determined in a multilayer method by averaging in order to reduce the measurement uncertainty. 	The uncertainty of measurement is determined with a uncertainty measurement balance sheet on the basis of the guideline VDI/VDE 2617 part 11:2011. The uncertainty of measurement for specific feedings is specified with a coverage probability of approximately 95 % (coverage factor $k = 2$) Exemplary measurement uncertainty for a described measuring tasks: Gauge block with a nominal value of 1000 mm, determined is the expanded uncertainty of the inspection feature „Distance“: $U = 4.8 \mu\text{m}$	For general measuring tasks the measuring uncertainty could be significant differently from the exemplary specified.

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Radius gauges	1 mm to 2500 mm	TK 86:2020-01	The uncertainty of measurement is determined with a uncertainty measurement balance sheet on the basic of the guideline VDI/VDE 2617 part 11:2011. The uncertainty of measurement is specified with a coverage probability of approximately 95 % (coverage factor $k = 2$) Uncertainty of measurement for a measuring problem: Radius with nominal value of 4 mm and an arc of 70°: $U = 10 \mu\text{m}$	
Calibration of control geometries of test and setting gauges with utilities		TK 88:2020-11		
	0 mm to 2000 mm		$38 \mu\text{m} + 26 \cdot 10^{-6} \cdot l$	Calipers, height gauges
	0 mm to 50 mm		$4.9 \mu\text{m} + 2 \cdot 10^{-6} \cdot l$	Micrometers
	0 mm to 1500 mm		$0.2 \mu\text{m} + 4 \cdot 10^{-6} \cdot l$	Horizontal and vertical length measuring device
	15 mm to 150 mm		$2.5 \mu\text{m} + 2.7 \cdot 10^{-6} \cdot l$	Bore gauges
	0° to 360°		0.08°	Universal angle meter, protractors
DC and low frequency quantities				
DC voltage Measuring instruments	0 V 1 mV to < 330 mV 0.33 V to < 3.3 V 3.3 V to < 33 V 33 V to < 330 V 330 V to < 1020 V		2.0 μV $1.5 \mu\text{V} + 15 \cdot 10^{-6} \cdot U$ $1.8 \mu\text{V} + 8 \cdot 10^{-6} \cdot U$ $15 \mu\text{V} + 10 \cdot 10^{-6} \cdot U$ $0.12 \text{ mV} + 13 \cdot 10^{-6} \cdot U$ $1.2 \text{ mV} + 13 \cdot 10^{-6} \cdot U$	$U = \text{measured value}$
DC voltage Sources	0 V 1 mV to 120 mV > 0.12 V to 1.2 V > 1.2 V to 12 V > 12 V to 120 V > 120 V to 1050 V		2.0 μV $1.3 \mu\text{V} + 6 \cdot 10^{-6} \cdot U$ $1.0 \mu\text{V} + 8 \cdot 10^{-6} \cdot U$ $1.0 \mu\text{V} + 9 \cdot 10^{-6} \cdot U$ $35 \mu\text{V} + 11 \cdot 10^{-6} \cdot U$ $0.11 \text{ mV} + 22 \cdot 10^{-6} \cdot U$	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
AC voltage Measuring instruments	1 mV to < 33 mV	10 Hz to 45 Hz > 45 Hz to 10 kHz > 10 kHz to 20 kHz > 20 kHz to 50 kHz > 50 kHz to 100 kHz > 100 kHz to 500 kHz	$5 \mu\text{V} + 0.5 \cdot 10^{-3} \cdot U$ $5 \mu\text{V} + 0.11 \cdot 10^{-3} \cdot U$ $5 \mu\text{V} + 0.14 \cdot 10^{-3} \cdot U$ $5 \mu\text{V} + 0.64 \cdot 10^{-3} \cdot U$ $10 \mu\text{V} + 2.4 \cdot 10^{-3} \cdot U$ $40 \mu\text{V} + 4.8 \cdot 10^{-3} \cdot U$	$U = \text{measured value}$
	33 mV to < 330 mV	10 Hz to 45 Hz > 45 Hz to 10 kHz > 10 kHz to 20 kHz > 20 kHz to 50 kHz > 50 kHz to 100 kHz > 100 kHz to 500 kHz	$6 \mu\text{V} + 0.24 \cdot 10^{-3} \cdot U$ $7 \mu\text{V} + 0.12 \cdot 10^{-3} \cdot U$ $7 \mu\text{V} + 0.12 \cdot 10^{-3} \cdot U$ $7 \mu\text{V} + 0.24 \cdot 10^{-3} \cdot U$ $25 \mu\text{V} + 0.47 \cdot 10^{-3} \cdot U$ $55 \mu\text{V} + 1.3 \cdot 10^{-3} \cdot U$	
	0.33 V to < 3.3 V	10 Hz to 45 Hz > 45 Hz to 10 kHz > 10 kHz to 20 kHz > 20 kHz to 50 kHz > 50 kHz to 100 kHz > 100 kHz to 500 kHz	$35 \mu\text{V} + 0.24 \cdot 10^{-3} \cdot U$ $47 \mu\text{V} + 0.11 \cdot 10^{-3} \cdot U$ $47 \mu\text{V} + 0.13 \cdot 10^{-3} \cdot U$ $40 \mu\text{V} + 0.2 \cdot 10^{-3} \cdot U$ $0.1 \text{ mV} + 0.43 \cdot 10^{-3} \cdot U$ $0.47 \text{ mV} + 1.6 \cdot 10^{-3} \cdot U$	
	3.3 V to < 33 V	10 Hz to 45 Hz > 45 Hz to 10 kHz > 10 kHz to 20 kHz > 20 kHz to 50 kHz > 50 kHz to 100 kHz	$0.46 \text{ mV} + 0.24 \cdot 10^{-3} \cdot U$ $0.47 \text{ mV} + 0.1 \cdot 10^{-3} \cdot U$ $0.47 \text{ mV} + 0.18 \cdot 10^{-3} \cdot U$ $0.47 \text{ mV} + 0.24 \cdot 10^{-3} \cdot U$ $1.3 \text{ mV} + 0.6 \cdot 10^{-3} \cdot U$	
	33 V to < 330 V	10 Hz to 45 Hz > 45 Hz to 10 kHz > 10 kHz to 20 kHz > 20 kHz to 50 kHz > 50 kHz to 100 kHz	$1.6 \text{ mV} + 0.12 \cdot 10^{-3} \cdot U$ $4.7 \text{ mV} + 0.13 \cdot 10^{-3} \cdot U$ $4.7 \text{ mV} + 0.18 \cdot 10^{-3} \cdot U$ $4.5 \text{ mV} + 0.21 \cdot 10^{-3} \cdot U$ $40 \text{ mV} + 1.3 \cdot 10^{-3} \cdot U$	
	330 V to < 1000 V	45 Hz to 1 kHz > 1 kHz to 5 kHz > 5 kHz to 10 kHz	$7.7 \text{ mV} + 0.2 \cdot 10^{-3} \cdot U$ $7.7 \text{ mV} + 0.16 \cdot 10^{-3} \cdot U$ $7.7 \text{ mV} + 0.2 \cdot 10^{-3} \cdot U$	
	AC voltage Sources	1 mV to 120 mV	10 Hz to 40 Hz > 40 Hz to 1 kHz > 1 kHz to 20 kHz > 20 kHz to 50 kHz > 50 kHz to 100 kHz > 100 kHz to 300 kHz	
> 0.12 V to 1.2 V		10 Hz to 40 Hz > 40 Hz to 1 kHz > 1 kHz to 20 kHz > 20 kHz to 50 kHz > 50 kHz to 100 kHz > 100 kHz to 300 kHz > 300 kHz to 1 MHz	$40 \mu\text{V} + 83 \cdot 10^{-6} \cdot U$ $20 \mu\text{V} + 76 \cdot 10^{-6} \cdot U$ $20 \mu\text{V} + 0.15 \cdot 10^{-3} \cdot U$ $20 \mu\text{V} + 0.31 \cdot 10^{-3} \cdot U$ $20 \mu\text{V} + 0.81 \cdot 10^{-3} \cdot U$ $0.1 \text{ mV} + 3.1 \cdot 10^{-3} \cdot U$ $0.1 \text{ mV} + 11 \cdot 10^{-3} \cdot U$	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
AC voltage Sources	> 1.2 V to 12 V	10 Hz to 40 Hz > 40 Hz to 1 kHz > 1 kHz to 20 kHz > 20 kHz to 50 kHz > 50 kHz to 100 kHz > 100 kHz to 300 kHz > 300 kHz to 1 MHz	$0.4 \text{ mV} + 80 \cdot 10^{-6} \cdot U$ $0.2 \text{ mV} + 74 \cdot 10^{-6} \cdot U$ $0.2 \text{ mV} + 0.15 \cdot 10^{-3} \cdot U$ $0.2 \text{ mV} + 0.31 \cdot 10^{-3} \cdot U$ $0.2 \text{ mV} + 0.81 \cdot 10^{-3} \cdot U$ $1.0 \text{ mV} + 3.1 \cdot 10^{-3} \cdot U$ $1.0 \text{ mV} + 11 \cdot 10^{-3} \cdot U$	<i>U</i> = measured value
	> 12 V to 120 V	10 Hz to 40 Hz > 40 Hz to 1 kHz > 1 kHz to 20 kHz > 20 kHz to 50 kHz > 50 kHz to 100 kHz	$0.4 \text{ mV} + 0.21 \cdot 10^{-3} \cdot U$ $0.2 \text{ mV} + 0.21 \cdot 10^{-3} \cdot U$ $0.2 \text{ mV} + 0.21 \cdot 10^{-3} \cdot U$ $0.2 \text{ mV} + 0.36 \cdot 10^{-3} \cdot U$ $0.1 \text{ mV} + 1.3 \cdot 10^{-3} \cdot U$	
	> 120 V to 700 V	10 Hz to 40 Hz > 40 Hz to 1 kHz > 1 kHz to 20 kHz > 20 kHz to 50 kHz	$40 \text{ mV} + 0.41 \cdot 10^{-3} \cdot U$ $20 \text{ mV} + 0.41 \cdot 10^{-3} \cdot U$ $20 \text{ mV} + 0.61 \cdot 10^{-3} \cdot U$ $20 \text{ mV} + 1.3 \cdot 10^{-3} \cdot U$	
DC current Measuring instruments	0 A		1.0 nA	<i>I</i> = measured value
	10 µA to < 330 µA		$20 \text{ nA} + 0.1 \cdot 10^{-3} \cdot I$	
	0.33 mA to < 3.3 mA		$40 \text{ nA} + 70 \cdot 10^{-6} \cdot I$	
	3.3 mA to < 33 mA		$0.2 \text{ µA} + 70 \cdot 10^{-6} \cdot I$	
	33 mA to < 330 mA		$2.0 \text{ µA} + 70 \cdot 10^{-6} \cdot I$	
	0.33 A to < 1.1 A		$32 \text{ µA} + 0.13 \cdot 10^{-3} \cdot I$	
	1.1 A to < 3 A		$32 \text{ µA} + 0.24 \cdot 10^{-3} \cdot I$	
	3 A to < 11 A		$0.39 \text{ mA} + 0.3 \cdot 10^{-3} \cdot I$	
11 A to < 20.5 A		$0.6 \text{ mA} + 0.63 \cdot 10^{-3} \cdot I$		
DC current Sources	0 A		1.0 nA	
	10 µA to 120 µA		$1 \text{ nA} + 22 \cdot 10^{-6} \cdot I$	
	> 0.12 mA to 1.2 mA		$5 \text{ nA} + 22 \cdot 10^{-6} \cdot I$	
	> 1.2 mA to 12 mA		$50 \text{ nA} + 22 \cdot 10^{-6} \cdot I$	
	> 12 mA to 120 mA		$0.5 \text{ µA} + 37 \cdot 10^{-6} \cdot I$	
	> 0.12 A to 1 A		$10 \text{ µA} + 0.12 \cdot 10^{-3} \cdot I$	
	> 1 A to 10 A		$0.1 \text{ mA} + 60 \cdot 10^{-6} \cdot I$	
	> 10 A to 20 A		$0.12 \cdot 10^{-3} \cdot I$	with 10 mΩ Shunt
	> 20 A to 40 A		$0.4 \cdot 10^{-3} \cdot I$	
DC current Current clamps	0 A to < 0.1A		$12 \text{ µA} + 10 \cdot 10^{-6} \cdot I$	
	0.1 A to < 1 A		$20 \text{ µA} + 0.12 \cdot 10^{-3} \cdot I$	
	1 A to < 10 A		$0.11 \text{ mA} + 60 \cdot 10^{-6} \cdot I$	
	10 A to < 20 A		$1 \text{ mA} + 0.12 \cdot 10^{-3} \cdot I$	
	20 A to < 50 A		$1 \text{ mA} + 0.12 \cdot 10^{-3} \cdot I$	
	50 A to < 500 A		$6 \text{ mA} + 60 \cdot 10^{-6} \cdot I$	
	500 A to 1000 A		$20 \text{ mA} + 0.12 \cdot 10^{-3} \cdot I$	with 50 turn coil
AC current Measuring instruments	30 µA to < 330 µA	10 Hz to 20 Hz	$80 \text{ nA} + 1.3 \cdot 10^{-3} \cdot I$	
		> 20 Hz to 45 Hz	$80 \text{ nA} + 0.94 \cdot 10^{-3} \cdot I$	
		> 45 Hz to 1 kHz	$80 \text{ nA} + 0.78 \cdot 10^{-3} \cdot I$	
		> 1 kHz to 5 kHz	$0.12 \text{ µA} + 2.0 \cdot 10^{-3} \cdot I$	
		> 5 kHz to 10 kHz	$0.16 \text{ µA} + 4.7 \cdot 10^{-3} \cdot I$	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
AC current Measuring instruments	0.33 mA to < 3.3 mA	10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 1 kHz > 1 kHz to 5 kHz > 5 kHz to 10 kHz	$0.2 \mu\text{A} + 1.3 \cdot 10^{-3} \cdot I$ $0.2 \mu\text{A} + 0.78 \cdot 10^{-3} \cdot I$ $0.2 \mu\text{A} + 0.63 \cdot 10^{-3} \cdot I$ $0.3 \mu\text{A} + 1.3 \cdot 10^{-3} \cdot I$ $0.3 \mu\text{A} + 3.2 \cdot 10^{-3} \cdot I$	<i>I</i> = measured value
	3.3 mA to < 33 mA	10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 1 kHz > 1 kHz to 5 kHz > 5 kHz to 10 kHz	$1.6 \mu\text{A} + 1.2 \cdot 10^{-3} \cdot I$ $1.6 \mu\text{A} + 0.6 \cdot 10^{-3} \cdot I$ $1.6 \mu\text{A} + 0.28 \cdot 10^{-3} \cdot I$ $1.6 \mu\text{A} + 0.51 \cdot 10^{-3} \cdot I$ $2.5 \mu\text{A} + 1.3 \cdot 10^{-3} \cdot I$	
	33 mA to < 330 mA	10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 1 kHz > 1 kHz to 5 kHz > 5 kHz to 10 kHz	$16 \mu\text{A} + 1.2 \cdot 10^{-3} \cdot I$ $16 \mu\text{A} + 0.6 \cdot 10^{-3} \cdot I$ $16 \mu\text{A} + 0.28 \cdot 10^{-3} \cdot I$ $40 \mu\text{A} + 0.63 \cdot 10^{-3} \cdot I$ $80 \mu\text{A} + 1.3 \cdot 10^{-3} \cdot I$	
	0.33 A to < 1.1 A	10 Hz to 45 Hz > 45 Hz to 1 kHz > 1 kHz to 5 kHz > 5 kHz to 10 kHz	$80 \mu\text{A} + 1.2 \cdot 10^{-3} \cdot I$ $80 \mu\text{A} + 0.29 \cdot 10^{-3} \cdot I$ $0.8 \text{ mA} + 3.9 \cdot 10^{-3} \cdot I$ $4.0 \text{ mA} + 16 \cdot 10^{-3} \cdot I$	
	1.1 A to < 3 A	10 Hz to 45 Hz > 45 Hz to 1 kHz > 1 kHz to 5 kHz > 5 kHz to 10 kHz	$80 \mu\text{A} + 1.2 \cdot 10^{-3} \cdot I$ $80 \mu\text{A} + 0.39 \cdot 10^{-3} \cdot I$ $0.8 \text{ mA} + 3.9 \cdot 10^{-3} \cdot I$ $4.0 \text{ mA} + 16 \cdot 10^{-3} \cdot I$	
	3 A to < 11 A	45 Hz to 100 Hz > 100 Hz to 1 kHz > 1 kHz to 5 kHz	$1.6 \text{ mA} + 0.39 \cdot 10^{-3} \cdot I$ $1.6 \text{ mA} + 0.63 \cdot 10^{-3} \cdot I$ $1.6 \text{ mA} + 20 \cdot 10^{-3} \cdot I$	
	11 A to < 20.5 A	45 Hz to 100 Hz > 100 Hz to 1 kHz > 1 kHz to 5 kHz	$4 \text{ mA} + 0.78 \cdot 10^{-3} \cdot I$ $4 \text{ mA} + 1.1 \cdot 10^{-3} \cdot I$ $4 \text{ mA} + 20 \cdot 10^{-3} \cdot I$	
	AC current Sources	10 μA to 120 μA	10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 1 kHz	
> 0.12 mA to 1.2 mA		10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 100 Hz > 100 Hz to 5 kHz	$0.2 \mu\text{A} + 4.1 \cdot 10^{-3} \cdot I$ $0.2 \mu\text{A} + 1.6 \cdot 10^{-3} \cdot I$ $0.2 \mu\text{A} + 0.61 \cdot 10^{-3} \cdot I$ $0.2 \mu\text{A} + 0.36 \cdot 10^{-3} \cdot I$	
> 1.2 mA to 12 mA		10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 100 Hz > 100 Hz to 5 kHz	$2.0 \mu\text{A} + 4.1 \cdot 10^{-3} \cdot I$ $2.0 \mu\text{A} + 1.6 \cdot 10^{-3} \cdot I$ $2.0 \mu\text{A} + 0.61 \cdot 10^{-3} \cdot I$ $2.0 \mu\text{A} + 0.31 \cdot 10^{-3} \cdot I$	
> 12 mA to 120 mA		10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 100 Hz > 100 Hz to 5 kHz	$20 \mu\text{A} + 4.1 \cdot 10^{-3} \cdot I$ $20 \mu\text{A} + 1.6 \cdot 10^{-3} \cdot I$ $20 \mu\text{A} + 0.61 \cdot 10^{-3} \cdot I$ $20 \mu\text{A} + 0.32 \cdot 10^{-3} \cdot I$	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
AC current Sources	> 0.12 A to 1 A	10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 100 Hz > 100 Hz to 5 kHz	$0.20 \text{ mA} + 4.1 \cdot 10^{-3} \cdot I$ $0.20 \text{ mA} + 1.7 \cdot 10^{-3} \cdot I$ $0.20 \text{ mA} + 0.81 \cdot 10^{-3} \cdot I$ $0.20 \text{ mA} + 1.1 \cdot 10^{-3} \cdot I$	$I = \text{measured value}$
	> 1 A to 10 A > 10 A to 40 A	10 Hz to 1 kHz	$0.5 \text{ mA} + 0.23 \cdot 10^{-3} \cdot I$ $0.6 \text{ mA} + 0.67 \cdot 10^{-3} \cdot I$	with 10 mΩ Shunt
AC current Current clamps	0 A to < 0.1 A 0.1 A to < 1 A 1 A to < 10 A 10 A to < 20 A	45 Hz to 1 kHz	$24 \mu\text{A} + 0.6 \cdot 10^{-3} \cdot I$ $0.2 \text{ mA} + 1.1 \cdot 10^{-3} \cdot I$ $0.5 \text{ mA} + 0.23 \cdot 10^{-3} \cdot I$ $0.6 \text{ mA} + 0.67 \cdot 10^{-3} \cdot I$	
	20 A to < 50 A 50 A to < 500 A 500 A to < 1000 A	45 Hz to 440 Hz	$10 \text{ mA} + 1.1 \cdot 10^{-3} \cdot I$ $25 \text{ mA} + 0.23 \cdot 10^{-3} \cdot I$ $30 \text{ mA} + 0.67 \cdot 10^{-3} \cdot I$	with 50 turn coil
DC resistance Measuring instruments	0.01 Ω to < 11 Ω 11 Ω to < 33 Ω 33 Ω to < 110 Ω 110 Ω to < 1.1 kΩ 1.1 kΩ to < 11 kΩ 11 kΩ to < 110 kΩ 110 kΩ to < 1.1 MΩ 1.1 MΩ to < 3.3 MΩ 3.3 MΩ to < 11 MΩ 11 MΩ to < 33 MΩ 33 MΩ to < 110 MΩ 110 MΩ to < 330 MΩ 330 MΩ to < 1.1 GΩ		$0.8 \text{ m}\Omega + 32 \cdot 10^{-6} \cdot R$ $1.2 \text{ m}\Omega + 20 \cdot 10^{-6} \cdot R$ $1.2 \text{ m}\Omega + 18 \cdot 10^{-6} \cdot R$ $1.6 \text{ m}\Omega + 18 \cdot 10^{-6} \cdot R$ $16 \text{ m}\Omega + 18 \cdot 10^{-6} \cdot R$ $0.16 \Omega + 18 \cdot 10^{-6} \cdot R$ $1.6 \Omega + 20 \cdot 10^{-6} \cdot R$ $23 \Omega + 33 \cdot 10^{-6} \cdot R$ $40 \Omega + 86 \cdot 10^{-6} \cdot R$ $200 \Omega + 0.16 \cdot 10^{-3} \cdot R$ $240 \Omega + 0.32 \cdot 10^{-3} \cdot R$ $8 \text{ k}\Omega + 2 \cdot 10^{-3} \cdot R$ $40 \text{ k}\Omega + 9.5 \cdot 10^{-3} \cdot R$	$R = \text{measured value}$
DC resistance Sources	0.1 mΩ to < 10 mΩ 0.01 Ω to < 1 Ω 1 Ω to 12 Ω > 12 Ω to 120 Ω > 120 Ω to 1.2 kΩ > 1.2 kΩ to 12 kΩ > 12 kΩ to 120 kΩ > 120 kΩ to 1.2 MΩ > 1.2 MΩ to 10 MΩ > 10 MΩ to 100 MΩ > 100 MΩ to 1 GΩ 1 GΩ to < 10 GΩ 10 GΩ to < 20 GΩ 20 GΩ to < 50 GΩ 50 GΩ to < 100 GΩ		$70 \text{ n}\Omega + 0.72 \cdot 10^{-3} \cdot R$ $0.5 \mu\Omega + 0.16 \cdot 10^{-3} \cdot R$ $60 \mu\Omega + 18 \cdot 10^{-6} \cdot R$ $0.5 \text{ m}\Omega + 15 \cdot 10^{-6} \cdot R$ $0.5 \text{ m}\Omega + 13 \cdot 10^{-6} \cdot R$ $5 \text{ m}\Omega + 11 \cdot 10^{-6} \cdot R$ $50 \text{ m}\Omega + 11 \cdot 10^{-6} \cdot R$ $2.1 \Omega + 16 \cdot 10^{-6} \cdot R$ $0.1 \text{ k}\Omega + 56 \cdot 10^{-6} \cdot R$ $0.11 \cdot 10^{-3} \cdot R$ $0.13 \cdot 10^{-3} \cdot R$ $0.43 \cdot 10^{-3} \cdot R$ $0.75 \cdot 10^{-3} \cdot R$ $2.0 \cdot 10^{-3} \cdot R$ $3.7 \cdot 10^{-3} \cdot R$	
DC power Measuring instruments	0.1 W to < 336 W 1 W to < 3059 W 10 W to 20.9 kW	3.3 mA to < 0.33 A 0.33 A to < 3 A 3 A to 20.5 A	$0.3 \cdot 10^{-3} \cdot P$ $0.4 \cdot 10^{-3} \cdot P$ $0.9 \cdot 10^{-3} \cdot P$	$P = \text{measured value}$
	0.1 W to < 20.9 kW 10 W to < 153 kW 100 W to 1 MW	3.3 mA to < 20.5 A 20.5 A to < 150 A 150 A to 1 kA	$4 \cdot 10^{-3} \cdot P$ $6 \cdot 10^{-3} \cdot P$ $8 \cdot 10^{-3} \cdot P$	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
AC power Measuring instruments	1 W to 91.8 W	33 mA to < 90 mA	$1.5 \cdot 10^{-3} \cdot P$	Frequencies from 45 Hz to 65 Hz $\cos \varphi = 1$ single-phase
	1 W to 336 W	90 mA to < 0.33 A	$1.0 \cdot 10^{-3} \cdot P$	
	1 W to 917 W	0.33 A to < 0.9 A	$1.4 \cdot 10^{-3} \cdot P$	
	1 W to 2243 W	0.9 A to < 2.2 A	$1.2 \cdot 10^{-3} \cdot P$	
	10 W to 4590 W	2.2 A to < 4.5 A	$1.4 \cdot 10^{-3} \cdot P$	
	10 W to 20.9 kW	4.5 A to < 20.5 A	$1.3 \cdot 10^{-3} \cdot P$	
	1 W to < 20.9 kW	33 mA to < 20.5 A	$6 \cdot 10^{-3} \cdot P$	
Resistance Measuring instruments	10 kΩ to < 40 kΩ	$ U < 65 \text{ V}$	$2.5 \cdot 10^{-3} \cdot R$	R = measured value $ U $ = test voltage High impedance resistance e.g. Insulation tester for electrical safety
	40 kΩ to < 100 kΩ	$ U < 400 \text{ V}$	$2.5 \cdot 10^{-3} \cdot R$	
	100 kΩ to < 200 kΩ	$ U < 800 \text{ V}$	$2.5 \cdot 10^{-3} \cdot R$	
	200 kΩ to < 1 MΩ	$ U < 1100 \text{ V}$	$2.5 \cdot 10^{-3} \cdot R$	
	1 MΩ to < 2 MΩ	$ U < 1575 \text{ V}$	$3.6 \cdot 10^{-3} \cdot R$	
	2 MΩ to < 10 MΩ	$ U < 2500 \text{ V}$	$3.6 \cdot 10^{-3} \cdot R$	
	10 MΩ to < 1 GΩ	$ U < 3000 \text{ V}$	$6.0 \cdot 10^{-3} \cdot R$	
	10 MΩ to < 1 GΩ	$ U < 5500 \text{ V}$	$7.0 \cdot 10^{-3} \cdot R$	
	1 GΩ to < 10 GΩ	$ U < 3000 \text{ V}$	$13 \cdot 10^{-3} \cdot R$	
	1 GΩ to < 10 GΩ	$ U < 5500 \text{ V}$	$17 \cdot 10^{-3} \cdot R$	
Resistance Measuring instruments	100 mΩ to < 5 Ω		$10 \text{ m}\Omega + 2.3 \cdot 10^{-3} \cdot R$	Low impedance resistance e.g. PE resistance tester for electrical safety
	5 Ω to < 30 Ω		$10 \text{ m}\Omega + 1.7 \cdot 10^{-3} \cdot R$	
	30 Ω to < 200 Ω		$10 \text{ m}\Omega + 1.7 \cdot 10^{-3} \cdot R$	
	200 Ω to < 500 Ω		$1.8 \cdot 10^{-3} \cdot R$	
	500 Ω to < 10 kΩ		$1.7 \cdot 10^{-3} \cdot R$	
Resistance Measuring instruments	14 mΩ		0.4 mΩ	Earth resistance Line impedance Loop impedance e.g. PE resistance tester or ground resistance tester for electrical safety
	39 mΩ		0.6 mΩ	
	94 mΩ		1 mΩ	
	340 mΩ		1.6 mΩ	
	490 mΩ		2.1 mΩ	
	960 mΩ		3.8 mΩ	
	1.7 Ω		6.6 mΩ	
	4.7 Ω		20 mΩ	
	9 Ω		35 mΩ	
	17 Ω		35 mΩ	
	47 Ω		250 mΩ	
	90 Ω		400 mΩ	
	170 Ω		800 mΩ	
	470 Ω		2 Ω	
	900 Ω		4 Ω	
1.7 kΩ		8 Ω		
Leakage current Measuring instruments	0.1 mA to < 0.3 mA		$3 \mu\text{A} + 2 \cdot 10^{-3} \cdot I$	I = measured value e.g. leakage current tester for electrical safety
	0.3 mA to < 3 mA		$4 \mu\text{A} + 3 \cdot 10^{-3} \cdot I$	
	3 mA to 30 mA		$30 \mu\text{A} + 3 \cdot 10^{-3} \cdot I$	
RCD initiation time Measuring instruments	10 mA to 3 A		$12 \cdot 10^{-3} \cdot I$	I = measured value

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Permanent Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
RCD initiation time Measuring instruments	10 ms to 5 s		$0,25 \text{ ms} + 0.2 \cdot 10^{-3} \cdot t$	$t = \text{measured value}$
Oscilloscope quantities				
Vertical deflection	5 mV _{pp} to < 0.5 V _{pp} 0.5 V _{pp} to 6.6 V _{pp}	DC, 10 Hz to 1 kHz	$40 \mu\text{V} + 2.2 \cdot 10^{-3} \cdot U$ $2.2 \cdot 10^{-3} \cdot U$	$R_i = 50 \Omega$
	5 mV _{pp} to < 0.5 V _{pp} 0.5 V _{pp} to 6.6 V _{pp}	> 1 kHz to 10 kHz	$40 \mu\text{V} + 2.5 \cdot 10^{-3} \cdot U$ $2.5 \cdot 10^{-3} \cdot U$	
	5 mV _{pp} to < 0.5 V _{pp} 0.5 V _{pp} to 130 V _{pp}	DC, 10 Hz to 1 kHz	$40 \mu\text{V} + 1.5 \cdot 10^{-3} \cdot U$ $1.5 \cdot 10^{-3} \cdot U$	$R_i = 1 \text{ M}\Omega$
	5 mV _{pp} to < 0.5 V _{pp} 0.5 V _{pp} to 130 V _{pp}	> 1 kHz to 10 kHz	$40 \mu\text{V} + 2.5 \cdot 10^{-3} \cdot U$ $2.5 \cdot 10^{-3} \cdot U$	
Horizontal deflection	1 ns to 20 ms > 50 ms to 5 s		$2.5 \cdot 10^{-6} \cdot t$ $(25 \cdot 10^{-6} + 1 \cdot 10^{-3} \cdot \frac{t_s}{s}) \cdot t$	$R_i = 50 \Omega$ $t = \text{time in s}$ $t_s = \text{triggered time in s}$
Bandwidth	5 mV to 5.5 V	50 kHz to 100 MHz > 100 MHz to 300 MHz > 300 MHz to 600 MHz	$30 \cdot 10^{-3} \cdot f$ $35 \cdot 10^{-3} \cdot f$ $45 \cdot 10^{-3} \cdot f$	$R_i = 50 \Omega$
Rise time	0.5 ns to 10 ms	5 mV to 2.5 V at 1 kHz to 10 MHz	$50 \cdot 10^{-3} \cdot t_r$	$t_r = \text{Rise time}$
Input resistance	40 Ω to 60 Ω		$2 \cdot 10^{-3} \cdot R$	$R = \text{measured value}$ 50 Ω nominal input resistance
	500 k Ω to 1.5 M Ω		$2 \cdot 10^{-3} \cdot R$	$R = \text{measured value}$ 1 M Ω nominal input resistance
Time and frequency				
Frequency	1 Hz to 2.2 GHz		$2 \cdot 10^{-10} \cdot f + U_{Tf}$	$f, t = \text{measured value}$
Time interval	1 μs to 10 s		$2 \cdot 10^{-10} \cdot t + U_{Tt} + 1 \text{ ns}$	$U_{Tf}, U_{Tt} = \text{trigger uncertainty}$

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 19 of 29

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

Annex to the Partial Accreditation Certificate D-K-15118-01-01

On-site Calibration

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Length Surface plates * Flatness deviation	to 50 µm	VDI/VDE/DGQ 2618 part 6.2:2014 to 8 m edge length	$1.1 \mu\text{m} + 2.7 \cdot 10^{-6} \cdot l$	l = measured length with inclination measuring instruments
Height gauges *	0 mm to 1000 mm	VDI/VDE/DGQ 2618 part 16.1:2009	$1.0 \mu\text{m} + 1.4 \cdot 10^{-6} \cdot l$	till 1000 mm lead length
Deviation from straightness and perpendicularity	to 40 µm		3 µm	
Horizontal length measuring devices *	0 mm to 200 mm	VDI/VDE/DGQ 2618 part 17.1:2015	$0.12 \mu\text{m} + 0.6 \cdot 10^{-6} \cdot l$	with gauge blocks
Height calipers * with analogue display	0 mm to 600 mm	VDI/VDE/DGQ 2618 part 9.3:2006	$30 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	
with digital display			$20 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	
Coordinate measuring technology Measuring projectors Measuring microscopes *	Devices featuring a measuring plane with a face diagonal ≤ 900 mm	Calibration of metrological characteristics according to guideline DKD-R 4-3 part 18.1:2018, and the following standards and guidelines DIN EN ISO 10360 VDI/VDE 2617		l = measured length
Determination of probing error size P_{SX} and P_{SY} with a graduated scale made of glass according to VDI/VDE 2617 part 6.1:2019		0.8 µm		
The error of indication for size measurement E_{UX} , E_{UY} and E_{UXY} is determined with a graduated scale made of glass according to DIN EN ISO 10360-7:2011		$1.6 \mu\text{m} + 1 \cdot 10^{-6} \cdot l$		

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Mobile Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Length				
Gap gauges *	5 mm to 200 mm	VDI/VDE/DGQ 2618 part 4.7:2005	$3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	$l =$ measured length
Calipers for external, internal and depth dimensions *	0 mm to 300 mm	VDI/VDE/DGQ 2618 part 9.1:2006	$30 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	
	> 300 mm to 1500 mm		$50 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	
Depth calipers *	0 mm to 300 mm	VDI/VDE/DGQ 2618 part 9.2:2006	$30 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	
	> 300 mm to 1000 mm		$50 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	
Height calipers * with analogue display	0 mm to 600 mm	VDI/VDE/DGQ 2618 part 9.3:2006	$30 \mu\text{m} + 30 \cdot 10^{-6} \cdot l$	$l =$ measured length
			with digital display	
Micrometers *	0 mm to 100 mm	VDI/VDE/DGQ 2618 part 10.1:2001	$3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	$l =$ final value of the measuring range
	> 100 mm to 500 mm		$4 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
	> 500 mm to 1000 mm		$5 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
Micrometers according to DIN 863-3 form D10	0 mm to 100 mm	TK 2:2021-02	$5 \mu\text{m} + 10 \cdot 10^{-6} \cdot d$	$d =$ measured diameter
Reference gauges for micrometers *	25 mm to 1000 mm	VDI/VDE/DGQ 2618 part 4.4:2009	$2 \mu\text{m} + 20 \cdot 10^{-6} \cdot l$	$l =$ measured length
Internal micrometers with three-point contact *	3 mm to 200 mm	VDI/VDE/DGQ 2618 part 10.8:2002	$4 \mu\text{m} + 10 \cdot 10^{-6} \cdot d$	$d =$ measured diameter
Internal measuring instruments	3 mm to 200 mm	TK 57:2021-02	$2 \mu\text{m} + 10 \cdot 10^{-6} \cdot d$	
Dial gauges * Scale interval > 1 μm	to 100 mm	VDI/VDE/DGQ/DKD 2618 part 11.1:2021	$3.2 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	$l =$ measured length
			Scale interval $\leq 1 \mu\text{m}$	
Dial indicators *	to 3 mm	VDI/VDE/DGQ 2618 part 11.2:2002	1.9 μm	
Lever gauges *	to 1.6 mm	VDI/VDE/DGQ 2618 part 11.3:2002	2 μm	
Dial gauges * with digital display	to 100 mm	VDI/VDE/DGQ/DKD 2618 part 11.4:2020	$3 \mu\text{m} + 10 \cdot 10^{-6} \cdot l$	
Thickness gauges * Scale interval 1 μm	0 mm to 30 mm	VDI/VDE/DGQ 2618 part 12.1:2005	$1.1 \mu\text{m} + 8 \cdot 10^{-6} \cdot l$	
			Scale interval 10 μm	
Feeler gauges	10 μm to 2 mm	TK 19:2021-02	1.7 μm	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Mobile Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Lever gauges (quicktests) for external measurements *	0 mm to 100 mm	VDI/VDE/DGQ 2618 part 12.1:2005	6 μm	
Lever gauges (quicktests) for internal measurements *	2.5 mm to 500 mm	VDI/VDE/DGQ 2618 part 13.1:2005	6 μm	
Internal micrometers with two-point contact *	25 mm to 100 mm	VDI/VDE/DGQ 2618 part 10.7:2010	3 μm + 10 · 10 ⁻⁶ · l	
	> 100 mm to 500 mm		4 μm + 10 · 10 ⁻⁶ · l	
	> 500 mm to 1000 mm		5 μm + 10 · 10 ⁻⁶ · l	
Extensions for internal micrometers with two-point contact *	25 mm to 1000 mm	VDI/VDE/DGQ 2618 part 10.7:2010	2 μm + 20 · 10 ⁻⁶ · l	
Micrometers with interchangeable inserts *	0 mm to 100 mm	VDI/VDE/DGQ 2618 part 10.2:2010	3 μm + 10 · 10 ⁻⁶ · l	
	> 100 mm to 300 mm		5 μm + 10 · 10 ⁻⁶ · l	
Micrometers with dial indicators *	0 mm to 100 mm	VDI/VDE/DGQ 2618 part 10.3:2002	3 μm + 10 · 10 ⁻⁶ · l	l = measured length
Micrometers heads *	0 mm to 50 mm	VDI/VDE/DGQ 2618 part 10.4:2008	3 μm + 10 · 10 ⁻⁶ · l	
Depth micrometers *	0 mm to 100 mm	VDI/VDE/DGQ 2618 part 10.5:2010	3 μm + 10 · 10 ⁻⁶ · l	
	> 100 mm to 500 mm		4 μm + 10 · 10 ⁻⁶ · l	
Bore gauges with two-point contact * Form I – III	1 mm to 800 mm	VDI/VDE/DGQ 2618 part 13.2:2005	2.3 μm	
Protractors * Flatness deviation	0° to 360°	VDI/VDE/DGQ 2618 part 7.2:2008	5 μm	
			Parallelism deviation	
Angle * Scale interval 5'	0° to 360°		4'	
Scale interval 1°	0° to 180°		24'	
Setting plug gauges * Diameter	1 mm to 500 mm	VDI/VDE/DGQ 2618 part 4.1:2006, option 3, option 4	0.8 μm + 6 · 10 ⁻⁶ · d	d = measured diameter
Setting ring gauges * Diameter	2 mm to 200 mm	VDI/VDE/DGQ 2618 part 4.1:2006 option 3, option 4	0.8 μm + 3 · 10 ⁻⁶ · d	
Measuring pins / Pins for screw threads * Diameter	0.17 mm to 50 mm	VDI/VDE/DGQ 2618 part 4.2:2007, option 1	0.8 μm	
Electrical probe and measuring device *	0 mm to 10 mm	VDI/VDE/DGQ 2618 part 14.1:2010	2 μm	
Layer thickness gauges	20 mm	TK 91:2021-02	0.7 μm + 180 · 10 ⁻⁶ · l	l = measured length

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 22 of 29

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Mobile Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Thread gauges * single-start cylindrical external and internal threads with straight flanks, symmetrical profile and nominal thread angle 55° to 60°				
External thread with nominal lead 0.25 mm to 5.5 mm Simple pitch diameter	Nominal diameter:	VDI/VDE/DGQ 2618 part 4.8:2006 (option 1) Three wire procedure (vertical to thread axis)	$2.8 \mu\text{m} + 10 \cdot 10^{-6} \cdot d$	$d = \text{pitch diameter}$
	2 mm to 200 mm			
Internal thread with nominal lead 0.7 mm to 6.0 mm Simple pitch diameter	Nominal diameter:	VDI/VDE/DGQ 2618 part 4.9:2006 (option 1) Two ball procedure (vertical to thread axis)	$2.8 \mu\text{m} + 10 \cdot 10^{-6} \cdot d$	
	4 mm to 200 mm			
DC and low frequency quantities				
DC voltage Measuring instruments	0 V 1 mV to < 330 mV 0.33 V to < 3.3 V 3.3 V to < 33 V 33 V to < 330 V 330 V to < 1020 V		2.0 μV $1.5 \mu\text{V} + 15 \cdot 10^{-6} \cdot U$ $1.8 \mu\text{V} + 8 \cdot 10^{-6} \cdot U$ $15 \mu\text{V} + 10 \cdot 10^{-6} \cdot U$ $0.12 \text{ mV} + 13 \cdot 10^{-6} \cdot U$ $1.2 \text{ mV} + 13 \cdot 10^{-6} \cdot U$	$U = \text{measured value}$
DC voltage Sources	0 V 1 mV to 120 mV > 0.12 V to 1.2 V > 1.2 V to 12 V > 12 V to 120 V > 120 V to 1050 V		2.0 μV $1.3 \mu\text{V} + 6 \cdot 10^{-6} \cdot U$ $1.0 \mu\text{V} + 8 \cdot 10^{-6} \cdot U$ $1.0 \mu\text{V} + 9 \cdot 10^{-6} \cdot U$ $35 \mu\text{V} + 11 \cdot 10^{-6} \cdot U$ $0.11 \text{ mV} + 22 \cdot 10^{-6} \cdot U$	
AC voltage Measuring instruments	1 mV to < 33 mV	10 Hz to 45 Hz > 45 Hz to 10 kHz > 10 kHz to 20 kHz > 20 kHz to 50 kHz > 50 kHz to 100 kHz > 100 kHz to 500 kHz	$5 \mu\text{V} + 0.5 \cdot 10^{-3} \cdot U$ $5 \mu\text{V} + 0.11 \cdot 10^{-3} \cdot U$ $5 \mu\text{V} + 0.14 \cdot 10^{-3} \cdot U$ $5 \mu\text{V} + 0.64 \cdot 10^{-3} \cdot U$ $10 \mu\text{V} + 2.4 \cdot 10^{-3} \cdot U$ $40 \mu\text{V} + 4.8 \cdot 10^{-3} \cdot U$	$U = \text{measured value}$
	33 mV to < 330 mV	10 Hz to 45 Hz > 45 Hz to 10 kHz > 10 kHz to 20 kHz > 20 kHz to 50 kHz > 50 kHz to 100 kHz > 100 kHz to 500 kHz	$6 \mu\text{V} + 0.24 \cdot 10^{-3} \cdot U$ $7 \mu\text{V} + 0.12 \cdot 10^{-3} \cdot U$ $7 \mu\text{V} + 0.12 \cdot 10^{-3} \cdot U$ $7 \mu\text{V} + 0.24 \cdot 10^{-3} \cdot U$ $25 \mu\text{V} + 0.47 \cdot 10^{-3} \cdot U$ $55 \mu\text{V} + 1.3 \cdot 10^{-3} \cdot U$	
	0.33 V to < 3.3 V	10 Hz to 45 Hz > 45 Hz to 10 kHz > 10 kHz to 20 kHz > 20 kHz to 50 kHz > 50 kHz to 100 kHz > 100 kHz to 500 kHz	$35 \mu\text{V} + 0.24 \cdot 10^{-3} \cdot U$ $47 \mu\text{V} + 0.11 \cdot 10^{-3} \cdot U$ $47 \mu\text{V} + 0.13 \cdot 10^{-3} \cdot U$ $40 \mu\text{V} + 0.2 \cdot 10^{-3} \cdot U$ $0.1 \text{ mV} + 0.43 \cdot 10^{-3} \cdot U$ $0.47 \text{ mV} + 1.6 \cdot 10^{-3} \cdot U$	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Mobile Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
AC voltage Measuring instruments	3.3 V to < 33 V	10 Hz to 45 Hz	$0.46 \text{ mV} + 0.24 \cdot 10^{-3} \cdot U$	$U = \text{measured value}$
		> 45 Hz to 10 kHz	$0.47 \text{ mV} + 0.1 \cdot 10^{-3} \cdot U$	
		> 10 kHz to 20 kHz	$0.47 \text{ mV} + 0.18 \cdot 10^{-3} \cdot U$	
		> 20 kHz to 50 kHz	$0.47 \text{ mV} + 0.24 \cdot 10^{-3} \cdot U$	
		> 50 kHz to 100 kHz	$1.3 \text{ mV} + 0.6 \cdot 10^{-3} \cdot U$	
	33 V to < 330 V	10 Hz to 45 Hz	$1.6 \text{ mV} + 0.12 \cdot 10^{-3} \cdot U$	
		> 45 Hz to 10 kHz	$4.7 \text{ mV} + 0.13 \cdot 10^{-3} \cdot U$	
		> 10 kHz to 20 kHz	$4.7 \text{ mV} + 0.18 \cdot 10^{-3} \cdot U$	
		> 20 kHz to 50 kHz	$4.5 \text{ mV} + 0.21 \cdot 10^{-3} \cdot U$	
> 50 kHz to 100 kHz		$40 \text{ mV} + 1.3 \cdot 10^{-3} \cdot U$		
330 V to < 1000 V	45 Hz to 1 kHz	$7.7 \text{ mV} + 0.2 \cdot 10^{-3} \cdot U$		
> 1 kHz to 5 kHz	$7.7 \text{ mV} + 0.16 \cdot 10^{-3} \cdot U$			
> 5 kHz to 10 kHz	$7.7 \text{ mV} + 0.2 \cdot 10^{-3} \cdot U$			
AC voltage Sources	1 mV to 120 mV	10 Hz to 40 Hz	$4 \mu\text{V} + 85 \cdot 10^{-6} \cdot U$	
		> 40 Hz to 1 kHz	$2 \mu\text{V} + 80 \cdot 10^{-6} \cdot U$	
		> 1 kHz to 20 kHz	$2 \mu\text{V} + 0.15 \cdot 10^{-3} \cdot U$	
		> 20 kHz to 50 kHz	$2 \mu\text{V} + 0.31 \cdot 10^{-3} \cdot U$	
		> 50 kHz to 100 kHz	$2 \mu\text{V} + 0.81 \cdot 10^{-3} \cdot U$	
		> 100 kHz to 300 kHz	$10 \mu\text{V} + 3.1 \cdot 10^{-3} \cdot U$	
	> 0.12 V to 1.2 V	10 Hz to 40 Hz	$40 \mu\text{V} + 83 \cdot 10^{-6} \cdot U$	
		> 40 Hz to 1 kHz	$20 \mu\text{V} + 76 \cdot 10^{-6} \cdot U$	
		> 1 kHz to 20 kHz	$20 \mu\text{V} + 0.15 \cdot 10^{-3} \cdot U$	
		> 20 kHz to 50 kHz	$20 \mu\text{V} + 0.31 \cdot 10^{-3} \cdot U$	
		> 50 kHz to 100 kHz	$20 \mu\text{V} + 0.81 \cdot 10^{-3} \cdot U$	
		> 100 kHz to 300 kHz	$0.1 \text{ mV} + 3.1 \cdot 10^{-3} \cdot U$	
	> 1.2 V to 12 V	> 300 kHz to 1 MHz	$0.1 \text{ mV} + 11 \cdot 10^{-3} \cdot U$	
		10 Hz to 40 Hz	$0.4 \text{ mV} + 80 \cdot 10^{-6} \cdot U$	
		> 40 Hz to 1 kHz	$0.2 \text{ mV} + 74 \cdot 10^{-6} \cdot U$	
		> 1 kHz to 20 kHz	$0.2 \text{ mV} + 0.15 \cdot 10^{-3} \cdot U$	
		> 20 kHz to 50 kHz	$0.2 \text{ mV} + 0.31 \cdot 10^{-3} \cdot U$	
		> 50 kHz to 100 kHz	$0.2 \text{ mV} + 0.81 \cdot 10^{-3} \cdot U$	
	> 100 kHz to 300 kHz	> 100 kHz to 300 kHz	$1.0 \text{ mV} + 3.1 \cdot 10^{-3} \cdot U$	
		> 300 kHz to 1 MHz	$1.0 \text{ mV} + 11 \cdot 10^{-3} \cdot U$	
		10 Hz to 40 Hz	$0.4 \text{ mV} + 0.21 \cdot 10^{-3} \cdot U$	
		> 40 Hz to 1 kHz	$0.2 \text{ mV} + 0.21 \cdot 10^{-3} \cdot U$	
		> 1 kHz to 20 kHz	$0.2 \text{ mV} + 0.21 \cdot 10^{-3} \cdot U$	
		> 20 kHz to 50 kHz	$0.2 \text{ mV} + 0.36 \cdot 10^{-3} \cdot U$	
> 50 kHz to 100 kHz	> 50 kHz to 100 kHz	$0.1 \text{ mV} + 1.3 \cdot 10^{-3} \cdot U$		
	> 12 V to 120 V	$0.4 \text{ mV} + 0.21 \cdot 10^{-3} \cdot U$		
	> 40 Hz to 1 kHz	$0.2 \text{ mV} + 0.21 \cdot 10^{-3} \cdot U$		
	> 1 kHz to 20 kHz	$0.2 \text{ mV} + 0.21 \cdot 10^{-3} \cdot U$		
	> 20 kHz to 50 kHz	$0.2 \text{ mV} + 0.36 \cdot 10^{-3} \cdot U$		
	> 50 kHz to 100 kHz	$0.1 \text{ mV} + 1.3 \cdot 10^{-3} \cdot U$		
> 120 V to 700 V	> 120 V to 700 V	$40 \text{ mV} + 0.41 \cdot 10^{-3} \cdot U$		
	> 40 Hz to 1 kHz	$20 \text{ mV} + 0.41 \cdot 10^{-3} \cdot U$		
	> 1 kHz to 20 kHz	$20 \text{ mV} + 0.61 \cdot 10^{-3} \cdot U$		
	> 20 kHz to 50 kHz	$20 \text{ mV} + 1.3 \cdot 10^{-3} \cdot U$		
	> 50 kHz to 100 kHz	$20 \text{ mV} + 1.3 \cdot 10^{-3} \cdot U$		

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 24 of 29

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Mobile Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
DC current Measuring instruments	0 A to < 330 µA 10 µA to < 3.3 mA 0.33 mA to < 33 mA 3.3 mA to < 330 mA 33 mA to < 1.1 A 0.33 A to < 3 A 1.1 A to < 11 A 3 A to < 20.5 A 11 A		1.0 nA 20 nA + 0.1 · 10 ⁻³ · I 40 nA + 70 · 10 ⁻⁶ · I 0.2 µA + 70 · 10 ⁻⁶ · I 2.0 µA + 70 · 10 ⁻⁶ · I 32 µA + 0.13 · 10 ⁻³ · I 32 µA + 0.24 · 10 ⁻³ · I 0.39 mA + 0.3 · 10 ⁻³ · I 0.6 mA + 0.63 · 10 ⁻³ · I	I = measured value
DC current Sources	0 A 10 µA to 120 µA > 0.12 mA to 1.2 mA > 1.2 mA to 12 mA > 12 mA to 120 mA > 0.12 A to 1 A 1 A to 10 A > 10 A to 20 A > 20 A to 40 A		1.0 nA 1 nA + 22 · 10 ⁻⁶ · I 5 nA + 22 · 10 ⁻⁶ · I 50 nA + 22 · 10 ⁻⁶ · I 0.5 µA + 37 · 10 ⁻⁶ · I 10 µA + 0.12 · 10 ⁻³ · I 0.1 mA + 60 · 10 ⁻⁶ · I 0.12 · 10 ⁻³ · I 0.4 · 10 ⁻³ · I	with 10 mΩ Shunt
DC current Current clamps	0 A to < 0.1 A 0.1 A to < 1 A 1 A to < 10 A 10 A to < 20 A 20 A to < 50 A 50 A to < 500 A 500 A to 1000 A		12 µA + 10 · 10 ⁻⁶ · I 20 µA + 0.12 · 10 ⁻³ · I 0.11 mA + 60 · 10 ⁻⁶ · I 1 mA + 0.12 · 10 ⁻³ · I 1 mA + 0.12 · 10 ⁻³ · I 6 mA + 60 · 10 ⁻⁶ · I 20 mA + 0.12 · 10 ⁻³ · I	with 50 turn coil
AC current Measuring instruments	30 µA to < 330 µA 0.33 mA to < 3.3 mA 3.3 mA to < 33 mA 33 mA to < 330 mA	10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 1 kHz > 1 kHz to 5 kHz > 5 kHz to 10 kHz 10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 1 kHz > 1 kHz to 5 kHz > 5 kHz to 10 kHz 10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 1 kHz > 1 kHz to 5 kHz > 5 kHz to 10 kHz	80 nA + 1.3 · 10 ⁻³ · I 80 nA + 0.94 · 10 ⁻³ · I 80 nA + 0.78 · 10 ⁻³ · I 0.12 µA + 2.0 · 10 ⁻³ · I 0.16 µA + 4.7 · 10 ⁻³ · I 0.2 µA + 1.3 · 10 ⁻³ · I 0.2 µA + 0.78 · 10 ⁻³ · I 0.2 µA + 0.63 · 10 ⁻³ · I 0.3 µA + 1.3 · 10 ⁻³ · I 0.3 µA + 3.2 · 10 ⁻³ · I 1.6 µA + 1.2 · 10 ⁻³ · I 1.6 µA + 0.6 · 10 ⁻³ · I 1.6 µA + 0.28 · 10 ⁻³ · I 1.6 µA + 0.51 · 10 ⁻³ · I 2.5 µA + 1.3 · 10 ⁻³ · I 16 µA + 1.2 · 10 ⁻³ · I 16 µA + 0.6 · 10 ⁻³ · I 16 µA + 0.28 · 10 ⁻³ · I 40 µA + 0.63 · 10 ⁻³ · I 80 µA + 1.3 · 10 ⁻³ · I	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 25 of 29

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Mobile Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
AC current Measuring instruments	0.33 A to < 1.1 A	10 Hz to 45 Hz > 45 Hz to 1 kHz > 1 kHz to 5 kHz > 5 kHz to 10 kHz	$80 \mu\text{A} + 1.2 \cdot 10^{-3} \cdot I$ $80 \mu\text{A} + 0.29 \cdot 10^{-3} \cdot I$ $0.8 \text{ mA} + 3.9 \cdot 10^{-3} \cdot I$ $4.0 \text{ mA} + 16 \cdot 10^{-3} \cdot I$	<i>I</i> = measured value
	1.1 A to < 3 A	10 Hz to 45 Hz > 45 Hz to 1 kHz > 1 kHz to 5 kHz > 5 kHz to 10 kHz	$80 \mu\text{A} + 1.2 \cdot 10^{-3} \cdot I$ $80 \mu\text{A} + 0.39 \cdot 10^{-3} \cdot I$ $0.8 \text{ mA} + 3.9 \cdot 10^{-3} \cdot I$ $4 \text{ mA} + 16 \cdot 10^{-3} \cdot I$	
	3 A to < 11 A	45 Hz to 100 Hz > 100 Hz to 1 kHz > 1 kHz to 5 kHz	$1.6 \text{ mA} + 0.39 \cdot 10^{-3} \cdot I$ $1.6 \text{ mA} + 0.63 \cdot 10^{-3} \cdot I$ $1.6 \text{ mA} + 20 \cdot 10^{-3} \cdot I$	
	11 A to < 20.5 A	45 Hz to 100 Hz > 100 Hz to 1 kHz > 1 kHz to 5 kHz	$4 \text{ mA} + 0.78 \cdot 10^{-3} \cdot I$ $4 \text{ mA} + 1.1 \cdot 10^{-3} \cdot I$ $4 \text{ mA} + 20 \cdot 10^{-3} \cdot I$	
AC current Sources	10 μA to 120 μA	10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 1 kHz	$30 \text{ nA} + 4.1 \cdot 10^{-3} \cdot I$ $30 \text{ nA} + 1.6 \cdot 10^{-3} \cdot I$ $30 \text{ nA} + 0.63 \cdot 10^{-3} \cdot I$	
	> 0.12 mA to 1.2 mA	10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 100 Hz > 100 Hz to 5 kHz	$02 \mu\text{A} + 4.1 \cdot 10^{-3} \cdot I$ $0.2 \mu\text{A} + 1.6 \cdot 10^{-3} \cdot I$ $0.2 \mu\text{A} + 0.61 \cdot 10^{-3} \cdot I$ $0.2 \mu\text{A} + 0.36 \cdot 10^{-3} \cdot I$	
	> 1.2 mA to 12 mA	10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 100 Hz > 100 Hz to 5 kHz	$2.0 \mu\text{A} + 4.1 \cdot 10^{-3} \cdot I$ $2.0 \mu\text{A} + 1.6 \cdot 10^{-3} \cdot I$ $2.0 \mu\text{A} + 0.61 \cdot 10^{-3} \cdot I$ $2.0 \mu\text{A} + 0.31 \cdot 10^{-3} \cdot I$	
	> 12 mA to 120 mA	10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 100 Hz > 100 Hz to 5 kHz	$20 \mu\text{A} + 4.1 \cdot 10^{-3} \cdot I$ $20 \mu\text{A} + 1.6 \cdot 10^{-3} \cdot I$ $20 \mu\text{A} + 0.61 \cdot 10^{-3} \cdot I$ $20 \mu\text{A} + 0.32 \cdot 10^{-3} \cdot I$	
	> 0.12 A to 1 A	10 Hz to 20 Hz > 20 Hz to 45 Hz > 45 Hz to 100 Hz > 100 Hz to 5 kHz	$0.20 \text{ mA} + 4.1 \cdot 10^{-3} \cdot I$ $0.20 \text{ mA} + 1.7 \cdot 10^{-3} \cdot I$ $0.20 \text{ mA} + 0.81 \cdot 10^{-3} \cdot I$ $0.20 \text{ mA} + 1.1 \cdot 10^{-3} \cdot I$	
	> 1 A to 10 A	10 Hz to 1 kHz	$0.5 \text{ mA} + 0.23 \cdot 10^{-3} \cdot I$	with 10 m Ω Shunt
	> 10 A to 40 A		$0.6 \text{ mA} + 0.67 \cdot 10^{-3} \cdot I$	
AC current Current clamps	0 A to < 0.1 A 0.1 A to < 1 A 1 A to < 10 A 10 A to < 20 A	45 Hz to 1 kHz	$24 \mu\text{A} + 0.6 \cdot 10^{-3} \cdot I$ $0.2 \text{ mA} + 1.1 \cdot 10^{-3} \cdot I$ $0.5 \text{ mA} + 0.23 \cdot 10^{-3} \cdot I$ $0.6 \text{ mA} + 0.67 \cdot 10^{-3} \cdot I$	
	20 A to < 50 A 50 A to < 500 A 500 A to < 1000 A	45 Hz to 440 Hz	$10 \text{ mA} + 1.1 \cdot 10^{-3} \cdot I$ $25 \text{ mA} + 0.23 \cdot 10^{-3} \cdot I$ $30 \text{ mA} + 0.67 \cdot 10^{-3} \cdot I$	with 50 turn coil

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 26 of 29

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Mobile Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
DC resistance Measuring instruments	0.01 Ω to < 11 Ω		$0.8 \text{ m}\Omega + 32 \cdot 10^{-6} \cdot R$	$R = \text{measured value}$
	11 Ω to < 33 Ω		$1.2 \text{ m}\Omega + 20 \cdot 10^{-6} \cdot R$	
	33 Ω to < 110 Ω		$1.2 \text{ m}\Omega + 18 \cdot 10^{-6} \cdot R$	
	110 Ω to < 1.1 kΩ		$1.6 \text{ m}\Omega + 18 \cdot 10^{-6} \cdot R$	
	1.1 kΩ to < 11 kΩ		$16 \text{ m}\Omega + 18 \cdot 10^{-6} \cdot R$	
	11 kΩ to < 110 kΩ		$0.16 \Omega + 18 \cdot 10^{-6} \cdot R$	
	110 kΩ to < 1.1 MΩ		$1.6 \Omega + 20 \cdot 10^{-6} \cdot R$	
	1.1 MΩ to < 3.3 MΩ		$23 \Omega + 33 \cdot 10^{-6} \cdot R$	
	3.3 MΩ to < 11 MΩ		$40 \Omega + 86 \cdot 10^{-6} \cdot R$	
	11 MΩ to < 33 MΩ		$200 \Omega + 0.16 \cdot 10^{-3} \cdot R$	
	33 MΩ to < 110 MΩ		$240 \Omega + 0.32 \cdot 10^{-3} \cdot R$	
	110 MΩ to < 330 MΩ		$8 \text{ k}\Omega + 2 \cdot 10^{-3} \cdot R$	
330 MΩ to < 1.1 GΩ		$40 \text{ k}\Omega + 9.5 \cdot 10^{-3} \cdot R$		
DC resistance Sources	0.1 mΩ to < 10 mΩ		$70 \text{ n}\Omega + 0.72 \cdot 10^{-3} \cdot R$	$R = \text{measured value}$
	0.01 Ω to < 1 Ω		$0.5 \mu\Omega + 0.16 \cdot 10^{-3} \cdot R$	
	1 Ω to 12 Ω		$60 \mu\Omega + 18 \cdot 10^{-6} \cdot R$	
	> 12 Ω to 120 Ω		$0.5 \text{ m}\Omega + 15 \cdot 10^{-6} \cdot R$	
	> 120 Ω to 1.2 kΩ		$0.5 \text{ m}\Omega + 13 \cdot 10^{-6} \cdot R$	
	> 1.2 kΩ to 12 kΩ		$5 \text{ m}\Omega + 11 \cdot 10^{-6} \cdot R$	
	> 12 kΩ to 120 kΩ		$50 \text{ m}\Omega + 11 \cdot 10^{-6} \cdot R$	
	> 120 kΩ to 1.2 MΩ		$2.1 \Omega + 16 \cdot 10^{-6} \cdot R$	
	> 1.2 MΩ to 10 MΩ		$0.1 \text{ k}\Omega + 56 \cdot 10^{-6} \cdot R$	
	> 10 MΩ to 100 MΩ		$0.11 \cdot 10^{-3} \cdot R$	
	> 100 MΩ to 1 GΩ		$0.13 \cdot 10^{-3} \cdot R$	
	1 GΩ to < 10 GΩ		$0.43 \cdot 10^{-3} \cdot R$	
	10 GΩ to < 20 GΩ		$0.75 \cdot 10^{-3} \cdot R$	
	20 GΩ to < 50 GΩ		$2.0 \cdot 10^{-3} \cdot R$	
	50 GΩ to < 100 GΩ		$3.7 \cdot 10^{-3} \cdot R$	
DC power Measuring instruments	0.1 W to < 336 W	3.3 mA to < 0.33 A	$0.3 \cdot 10^{-3} \cdot P$	$P = \text{measured value}$
	1 W to < 3059 W	0.33 A to < 3 A	$0.4 \cdot 10^{-3} \cdot P$	
	10 W to 20.9 kW	3 A to 20.5 A	$0.9 \cdot 10^{-3} \cdot P$	
	0.1 W to < 20.9 kW	3.3 mA to < 20.5 A	$4 \cdot 10^{-3} \cdot P$	
	10 W to < 153 kW	20.5 A to < 150 A	$6 \cdot 10^{-3} \cdot P$	
	100 W to 1 MW	150 A to 1 kA	$8 \cdot 10^{-3} \cdot P$	
AC power Measuring instruments	1 W to 91.8 W	33 mA to < 90 mA	$1.5 \cdot 10^{-3} \cdot P$	Frequencies from 45 Hz to 65 Hz $\cos \varphi = 1$ single-phase
	1 W to 336 W	90 mA to < 0.33 A	$1.0 \cdot 10^{-3} \cdot P$	
	1 W to 917 W	0.33 A to < 0.9 A	$1.4 \cdot 10^{-3} \cdot P$	
	1 W to 2243 W	0.9 A to < 2.2 A	$1.2 \cdot 10^{-3} \cdot P$	
	10 W to 4590 W	2.2 A to < 4.5 A	$1.4 \cdot 10^{-3} \cdot P$	
	10 W to 20.9 kW	4.5 A to < 20.5 A	$1.3 \cdot 10^{-3} \cdot P$	
	1 W to < 20.9 kW	33 mA to < 20.5 A	$6 \cdot 10^{-3} \cdot P$	
	10 W to < 153 kW	20.5 A to < 150 A	$10 \cdot 10^{-3} \cdot P$	
	100 W to 1 MW	150 A to 1 kA	$12 \cdot 10^{-3} \cdot P$	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 27 of 29

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Mobile Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Resistance Measuring instruments	10 kΩ to < 40 kΩ	$ U < 65 \text{ V}$	$2.5 \cdot 10^{-3} \cdot R$	R = measured value $ U $ = test voltage High impedance resistance e.g. Insulation tester for electrical safety
	40 kΩ to < 100 kΩ	$ U < 400 \text{ V}$	$2.5 \cdot 10^{-3} \cdot R$	
	100 kΩ to < 200 kΩ	$ U < 800 \text{ V}$	$2.5 \cdot 10^{-3} \cdot R$	
	200 kΩ to < 1 MΩ	$ U < 1100 \text{ V}$	$2.5 \cdot 10^{-3} \cdot R$	
	1 MΩ to < 2 MΩ	$ U < 1575 \text{ V}$	$3.6 \cdot 10^{-3} \cdot R$	
	2 MΩ to < 10 MΩ	$ U < 2500 \text{ V}$	$3.6 \cdot 10^{-3} \cdot R$	
	10 MΩ to < 1 GΩ	$ U < 3000 \text{ V}$	$6.0 \cdot 10^{-3} \cdot R$	
	10 MΩ to < 1 GΩ	$ U < 5500 \text{ V}$	$7.0 \cdot 10^{-3} \cdot R$	
	1 GΩ to < 10 GΩ	$ U < 3000 \text{ V}$	$13 \cdot 10^{-3} \cdot R$	
	1 GΩ to < 10 GΩ	$ U < 5500 \text{ V}$	$17 \cdot 10^{-3} \cdot R$	
10 GΩ to 100 GΩ	$ U < 5500 \text{ V}$	$40 \cdot 10^{-3} \cdot R$		
Resistance Measuring instruments	100 mΩ to < 5 Ω		$10 \text{ m}\Omega + 2.3 \cdot 10^{-3} \cdot R$	R = measured value Low impedance resistance e.g. PE resistance tester for electrical safety
	5 Ω to < 30 Ω		$10 \text{ m}\Omega + 1.7 \cdot 10^{-3} \cdot R$	
	30 Ω to < 200 Ω		$10 \text{ m}\Omega + 1.7 \cdot 10^{-3} \cdot R$	
	200 Ω to < 500 Ω		$1.8 \cdot 10^{-3} \cdot R$	
	500 Ω to < 10 kΩ		$1.7 \cdot 10^{-3} \cdot R$	
Resistance Measuring instruments	14 mΩ		0.4 mΩ	Earth resistance Line impedance Loop impedance e.g. PE resistance tester or ground resistance for electrical safety
	39 mΩ		0.6 mΩ	
	94 mΩ		1 mΩ	
	340 mΩ		1.6 mΩ	
	490 mΩ		2.1 mΩ	
	960 mΩ		3.8 mΩ	
	1.7 Ω		6.6 mΩ	
	4.7 Ω		20 mΩ	
	9 Ω		35 mΩ	
	17 Ω		35 mΩ	
	47 Ω		250 mΩ	
	90 Ω		400 mΩ	
	170 Ω		800 mΩ	
	470 Ω		2 Ω	
900 Ω		4 Ω		
1.7 kΩ		8 Ω		
Leakage current Measuring instruments	0.1 mA to < 0.3 mA		$3 \mu\text{A} + 2 \cdot 10^{-3} \cdot I$	I = measured value e.g. leakage current tester for electrical safety
	0.3 mA to < 3 mA		$4 \mu\text{A} + 3 \cdot 10^{-3} \cdot I$	
	3 mA to 30 mA		$30 \mu\text{A} + 3 \cdot 10^{-3} \cdot I$	
RCD initiation current Measuring instruments	10 mA to 3 A		$12 \cdot 10^{-3} \cdot I$	I = measured value
RCD initiation time Measuring instruments	10 ms to 5 s		$0.25 \text{ ms} + 0.2 \cdot 10^{-3} \cdot t$	t = measured value

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-01

Mobile Laboratory

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Oscilloscope quantities				
Vertical deflection	5 mV _{pp} to < 0.5 V _{pp} 0.5 V _{pp} to 6.6 V _{pp}	DC, 10 Hz to 1 kHz	$40 \mu\text{V} + 2.2 \cdot 10^{-3} \cdot U$ $2.2 \cdot 10^{-3} \cdot U$	$R_i = 50 \Omega$
	5 mV _{pp} to < 0.5 V _{pp} 0.5 V _{pp} to 6.6 V _{pp}	> 1 kHz to 10 kHz	$40 \mu\text{V} + 2.5 \cdot 10^{-3} \cdot U$ $2.5 \cdot 10^{-3} \cdot U$	
	5 mV _{pp} to < 0.5 V _{pp} 0.5 V _{pp} to 130 V _{pp}	DC, 10 Hz to 1 kHz	$40 \mu\text{V} + 1.5 \cdot 10^{-3} \cdot U$ $1.5 \cdot 10^{-3} \cdot U$	$R_i = 1 \text{ M}\Omega$
	5 mV _{pp} to < 0.5 V _{pp} 0.5 V _{pp} to 130 V _{pp}	> 1 kHz to 10 kHz	$40 \mu\text{V} + 2.5 \cdot 10^{-3} \cdot U$ $2.5 \cdot 10^{-3} \cdot U$	
Horizontal deflection	1 ns to 20 ms > 50 ms to 5 s		$2.5 \cdot 10^{-6} \cdot t$ $(25 \cdot 10^{-6} + 1 \cdot 10^{-3} \cdot \frac{t_s}{s}) \cdot t$	$R_i = 50 \Omega$ $t = \text{time in s}$ $t_s = \text{triggered time in s}$
Bandwidth	5 mV to 5.5 V	50 kHz to 100 MHz > 100 MHz to 300 MHz > 300 MHz to 600 MHz	$30 \cdot 10^{-3} \cdot f$ $35 \cdot 10^{-3} \cdot f$ $45 \cdot 10^{-3} \cdot f$	$R_i = 50 \Omega$
Rise time	0.5 ns to 10 ms	5 mV to 2.5 V at 1 kHz to 10 MHz	$50 \cdot 10^{-3} \cdot t_r$	$t_r = \text{Rise time}$
Input resistance	40 Ω to 60 Ω		$2 \cdot 10^{-3} \cdot R$	$R = \text{measured value}$ 50 Ω nominal input resistance
	500 k Ω to 1.5 M Ω		$2 \cdot 10^{-3} \cdot R$	$R = \text{measured value}$ 1 M Ω nominal input resistance

Abbreviations used:

CMC	Calibration and measurement capabilities (Kalibrier- und Messmöglichkeiten)
DGQ	Deutsche Gesellschaft für Qualität e.V.
DIN	Deutsches Institut für Normung e.V.
DKD	Deutscher Kalibrierdienst
DKD-R	Guideline of Deutscher Kalibrierdienst, published by Physikalisch-Technische Bundesanstalt
EURAMET	European Association of National Metrology Institutes
TK	Calibration guide of Kessler-QMP GmbH
VDE	Verband der Elektrotechnik, Elektronik und Informationstechnik e.V.
VDI	Verein Deutscher Ingenieure e.V.

β	Helix angle	$f_{i\beta}$	Helix form deviation
d	Reference diameter	$f_{H\beta}$	Helix slope deviation
d_b	Base diameter	F_p	Cumulative pitch deviation
F_α	Total profile deviation	f_p	Single pitch deviation
$f_{H\alpha}$	Profile slope deviation	L_α	Profile evaluation range
$f_{i\alpha}$	Profile form deviation	L_β	Helix evaluation range
F_β	Total helix deviation	m_n	Normal module

Valid from: 11.03.2025

Date of issue: 11.03.2025

Deutsche Akkreditierungsstelle

Annex to the Partial Accreditation Certificate D-K-15118-01-02 according to DIN EN ISO/IEC 17025:2018

Valid from: 11.03.2025

Date of issue: 11.03.2025

This annex is a part of the accreditation certificate D-K-15118-01-00.

Holder of partial accreditation certificate:

**Kessler QMP GmbH
Nisterberger Weg 16, 57520 Friedewald**

with the location

**Kessler QMP GmbH
Nisterberger Weg 16, 57520 Friedewald**

The calibration laboratory meets the requirements of DIN EN ISO/IEC 17025:2018 to carry out the conformity assessment activities listed in this annex. The calibration laboratory meets additional legal and normative requirements, if applicable, including those in relevant sectoral schemes, provided that these are explicitly confirmed below.

The management system requirements of DIN EN ISO/IEC 17025 are written in the language relevant to the operations of calibration laboratories and they conform to the principles of DIN EN ISO 9001.

This certificate annex is only valid together with the written accreditation certificate and reflects the status as indicated by the date of issue. The current status of any given scope of accreditation can be found in the directory of accredited bodies maintained by Deutsche Akkreditierungsstelle GmbH at <https://www.dakks.de>.

Annex to the Partial Accreditation Certificate D-K-15118-01-02

Calibrations in the fields:

Mechanical quantities

- Force
- Weighing instruments ^{a)}
- Torque ^{a), b)}
- Pressure ^{a), b)}

Thermodynamic quantities

Temperature quantities

- Direct reading thermometers

^{a)} also on-site-calibration

^{b)} also calibration in the mobile laboratory

The calibration laboratory is permitted, without being required to inform and obtain prior approval from DAkkS, to use calibration standards or equivalent calibration procedures listed here with different issue dates.

The calibration laboratory maintains a current list of all calibration standards / equivalent calibration procedures within the flexible scope of accreditation.

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 2 of 5

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

Annex to the Partial Accreditation Certificate D-K-15118-01-02
Permanent Laboratory
Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Force Force measuring devices	0.1 kN to 50 kN	DKD-R 3-3:2018	$1 \cdot 10^{-3}$	Compression and tension force
Torque Hand torque tools setting and indicating types	0.1 N·m to 3 kN·m	DIN EN ISO 6789-2:2017	$5 \cdot 10^{-3}$	
Torque measuring devices, torque measuring chain	0.1 N·m to 10 N·m	DIN 51309:2022	$2 \cdot 10^{-3}$	
	> 10 N·m to 5 kN·m		$8 \cdot 10^{-4}$	
Torque wrench calibration devices	1 N·m to 10 N·m	DKD-R 10-8:2020	$6 \cdot 10^{-3}$	
	> 10 N·m to 3 kN·m		$2 \cdot 10^{-3}$	
Pressure Absolute pressure p_{abs}	10 mbar to 2 bar	DKD-R 6-1:2014 Method of calibration: $p_{abs} = p_e + p_{amb}$	$2 \cdot 10^{-5} \cdot p_{abs} + 0.03 \text{ mbar}$	Pressure medium : gas The measurement uncertainty of the barometer U_{baro} is taken into account
	> 2 bar to 101 bar		5 mbar	
	> 101 bar to 201 bar		$5 \cdot 10^{-5} \cdot p_{abs} + 0.5 \text{ mbar}$	
Positive and negative gauge pressure p_e	-990 mbar to 1 bar	DKD-R 6-1:2014	$1 \cdot 10^{-5} \cdot p_e + 0.05 \text{ mbar}$	Pressure medium : gas
	> 1 bar to 100 bar		5 mbar	
	> 100 bar to 200 bar		$5 \cdot 10^{-5} \cdot p_e + 0.5 \text{ mbar}$	
Absolute pressure p_{abs}	1 bar to 101 bar	DKD-R 6-1:2014 Method of calibration: $p_{abs} = p_e + p_{amb}$	0.04 bar	Pressure medium: oil $p_{amb} = \text{barometric pressure}$ The measurement uncertainty of the barometer U_{baro} is taken into account
	> 101 bar to 1001 bar		$7 \cdot 10^{-4} \cdot p_{abs} + 0.04 \text{ bar}$	
	> 1001 bar to 7001 bar		$2 \cdot 10^{-3} \cdot p_{abs} + 0.04 \text{ bar}$	
Positive gauge pressure p_e	0 bar to 100 bar	DKD-R 6-1:2014	0.04 bar	Pressure medium: oil
	> 100 bar to 1000 bar		$7 \cdot 10^{-4} \cdot p_e + 0.04 \text{ bar}$	
	> 1000 bar to 7000 bar		$2 \cdot 10^{-3} \cdot p_e + 0.04 \text{ bar}$	
Weighing instruments Non-automatic weighing instruments	to 30 kg	EURAMET cg 18 version 4.0	$1.3 \cdot 10^{-6}$	with weights OIML R 111-1:2004 according to class E2
	to 100 kg		$6.6 \cdot 10^{-5}$	with weights OIML R 111-1:2004 according to class M1
Temperature quantities Direct reading thermometers with RTD	0 °C to 200 °C	DKD-R 5-1:2018	0.25 K	
	> 200 °C to 400 °C		0.4 K	
Direct reading thermometers with thermocouple	0 °C to 200 °C	DKD-R 5-3:2018	0.4 K	
	> 200 °C to 400 °C		0.5 K	

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 3 of 5

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

Annex to the Partial Accreditation Certificate D-K-15118-01-02

On-Site-Calibration

Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹	Remarks
Torque Torque wrench calibration devices	1 N·m to 10 N·m	DKD-R 10-8:2020	$6 \cdot 10^{-3}$	
	> 10 N·m to 3 kN·m		$2 \cdot 10^{-3}$	
Hand torque tools setting and indicating types	0.1 N·m to 1 kN·m	DIN EN ISO 6789-2:2017	$5 \cdot 10^{-3}$	
Pressure Absolute pressure p_{abs}	10 mbar to 2 bar	DKD-R 6-1:2014 Method of calibration: $p_{abs} = p_e + p_{amb}$	$2 \cdot 10^{-5} \cdot p_{abs} + 0.03 \text{ mbar}$	Pressure medium: gas The measurement uncertainty of the barometer U_{baro} is taken into account
	> 2 bar to 101 bar		5 mbar	
	> 101 bar to 201 bar		$5 \cdot 10^{-5} \cdot p_{abs} + 0.5 \text{ mbar}$	
Positive and negative gauge pressure p_e	-990 mbar to 1 bar	DKD-R 6-1:2014	$1 \cdot 10^{-5} \cdot p_e + 0.05 \text{ mbar}$	Pressure medium: gas
	> 1 bar to 100 bar		5 mbar	
	> 100 bar to 200 bar		$5 \cdot 10^{-5} \cdot p_e + 0.5 \text{ mbar}$	
Absolute pressure p_{abs}	1 bar to 101 bar	DKD-R 6-1:2014 Method of calibration: $p_{abs} = p_e + p_{amb}$	0.04 bar	Pressure medium: oil p_{amb} = barometric pressure The measurement uncertainty of the barometer U_{baro} is taken into account
	> 101 bar to 1001 bar		$7 \cdot 10^{-4} \cdot p_{abs} + 0.04 \text{ bar}$	
	> 1001 bar to 7001 bar		$2 \cdot 10^{-3} \cdot p_{abs} + 0.04 \text{ bar}$	
Positive gauge pressure p_e	0 bar to 100 bar	DKD-R 6-1:2014	0.04 bar	Pressure medium: oil
	> 100 bar to 1000 bar		$7 \cdot 10^{-4} \cdot p_e + 0.04 \text{ bar}$	
	> 1000 bar to 7000 bar		$2 \cdot 10^{-3} \cdot p_e + 0.04 \text{ bar}$	
Weighing instruments Non-automatic weighing instruments	to 30 kg	EURAMET cg 18 version 4.0	$1.3 \cdot 10^{-6}$	with weights OIML R 111-1:2004 according to class E2
	to 100 kg		$6.6 \cdot 10^{-5}$	with weights OIML R 111-1:2004 according to class M1

Valid from: 11.03.2025

Date of issue: 11.03.2025

Annex to the Partial Accreditation Certificate D-K-15118-01-02
Mobile Laboratory
Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement ¹⁾	Remarks
Pressure Absolute pressure p_{abs}	10 mbar to 2 bar	DKD-R 6-1:2014 Method of calibration: $p_{abs} = p_e + p_{amb}$	$2 \cdot 10^{-5} \cdot p_{abs} + 0.03 \text{ mbar}$	Pressure medium : gas The measurement uncertainty of the barometer U_{baro} is taken into account
	> 2 bar to 101 bar		5 mbar	
	> 101 bar to 201 bar		$5 \cdot 10^{-5} \cdot p_{abs} + 0.5 \text{ mbar}$	
Positive and negative gauge pressure p_e	-990 mbar to 1 bar	DKD-R 6-1:2014	$1 \cdot 10^{-5} \cdot p_e + 0.05 \text{ mbar}$	Pressure medium : gas
	> 1 bar to 100 bar		5 mbar	
	> 100 bar to 200 bar		$5 \cdot 10^{-5} \cdot p_e + 0.5 \text{ mbar}$	
Absolute pressure p_{abs}	1 bar to 101 bar	DKD-R 6-1:2014 Method of calibration: $p_{abs} = p_e + p_{amb}$	0.04 bar	Pressure medium: oil p_{amb} = barometric pressure The measurement uncertainty of the barometer U_{baro} is taken into account
	> 101 bar to 1001 bar		$7 \cdot 10^{-4} \cdot p_{abs} + 0.04 \text{ bar}$	
	> 1001 bar to 7001 bar		$2 \cdot 10^{-3} \cdot p_{abs} + 0.04 \text{ bar}$	
Positive gauge pressure p_e	0 bar to 100 bar	DKD-R 6-1:2014	0.04 bar	Pressure medium: oil
	> 100 bar to 1000 bar		$7 \cdot 10^{-4} \cdot p_e + 0.04 \text{ bar}$	
	> 1000 bar to 7000 bar		$2 \cdot 10^{-3} \cdot p_e + 0.04 \text{ bar}$	
Torque Torque wrench calibration devices	1 N·m to 10 N·m	DKD-R 10-8:2020	$6 \cdot 10^{-3}$	
	> 10 N·m to 3 kN·m		$2 \cdot 10^{-3}$	
Hand torque tools setting and indicating types	0.1 N·m to 1 kN·m	DIN EN ISO 6789-2:2017	$5 \cdot 10^{-3}$	

Abbreviations used:

CMC	Calibration and measurement capabilities
DIN	Deutsches Institut für Normung e.V.
DKD-R	Guideline of Deutscher Kalibrierdienst, published by Physikalisch-Technische Bundesanstalt
EURAMET	European Association of National Metrology Institutes

Valid from: 11.03.2025

Date of issue: 11.03.2025

Page 5 of 5

This document is a translation. The definitive version is the original German annex to the accreditation certificate.